

Test Report issued under the responsibility of:





TEST REPORT IEC 60601-1-2

Medical electrical equipment –

Part 1-2: General requirements for basic safety and essential performance – Collateral Standard: Electromagnetic disturbances – Requirements and tests

Report Number:	N40P0014
Date of issue:	Feb 24, 2020
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Name of Testing Laboratory preparing the Report:	SGS Germany GmbH, Consumer and Retail Hofmannstrasse 50 81379 Munich, Germany
Applicant's name:	ADLINK Technology GmbH
Address:	Ulrichsberger Str. 17
	94469 Deggendorf
	Germany
Test specification:	
Standard:	IEC 60601-1-2:2014
Test procedure:	СВ
Non-standard test method::	N/A
Test Report Form No	IEC60601 1 2E EMC
	12000001_1_122_1110
Test Report Form(s) Originator :	UL(US)
-	

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Test item description Me	Medical Panel Computer				
Trade Mark					
Manufacturer Al	DLINK Technology GmbH				
	LC 8 series:				
	1LC8-23				
Ratings 10	0 – 240 V ac; 50/60 Hz; Class 1				
Responsible Testing Laboratory (as	applicable), testing procedure and testing location(s):				
CB Testing Laboratory:	SGS Germany GmbH, Consumer and Retail				
Testing location/ address	Hofmannstrasse 50 81379 Munich, Germany				
Tested by (name, function,					
signature)	Sperling				
Approved by (name, function, signature)	91/21				
	Wössner Reh Work				
Testing procedure: CTF Stage 1:					
Testing location/ address					
Tested by (name, function, signature)					
Approved by (name, function, signature)					
Testing procedure: CTF Stage 2:					
Testing location/ address					
Tested by (name, function, signature)					
Witnessed by (name, function, signature)	Witnessed by (name, function,				
Approved by (name, function, signature)					

	Testing procedure: CTF Stage 3:	
	Testing procedure: CTF Stage 4:	
Test	ing location/ address	
	ed by (name, function, ature)	
	essed by (name, function, ature)	
	roved by (name, function, ature)	
	ervised by (name, function, ature)	

List of Attachments (including a total number of pages in each attachment): None				
Summary of testing:				
Tests performed (name of test and subclause):	Testing location:			
Conducted EMISSIONS (7.3)	SGS Germany			
Radiated EMISSIONS (7.3)	Consumer and Retail, EMC-Lab			
Disturbance Power EMISSIONS (7.3)	81379 Munich, Germany			
Harmonic Currents (7.2.1)	·····			
Voltage Fluctuations and Flicker (7.2.3)				
Electrostatic Discharges (8.9)				
RF Electromagnetic Fields (8.9)				
Proximity fields from RF wireless communications EQUIPMENT (8.10)				
Electrical Fast Transients (8.9)				
Surge (8.9)				
Conducted Disturbances Induced by RF Fields (8.9)				
Voltage Dips and Interruptions (8.9)				
Note: delete tests not conducted in the list above.				
Summary of compliance with National Differences:				
List of countries addressed				
$oxed{intermat}$ The product fulfils the requirements of IEC 6060	11-1-2: 2014 (Fourth Edition)			

Device modifications necessary for compliance:

(Describe ME EQUIPMENT or ME SYSTEM modifications needed in order to pass any of the EMISSIONS or IMMUNITY tests or delete the whole sentence and state: "not applicable")



Ferrite Würth 742 717 22 on MIC In and Line OUT cables

A statement that manufacturer will incorporate all changes into production units.

☐ Manufacturer provided declaration statement.

Manufacturer did not provide declaration statement.

Test item particulars:	None		
Classification of installation and use:	(see IEC 60601-1-2 Annex C for guidance in classification)		
	Emission limits to be considered:		
	Class A ¹		
	⊠ Class B		
	The medical equipment is classified following based on CISPR 11 and IEC 60601-1-2		
	Group 2		
	¹ If the more stringent class B limits are passed, also the class A limits can be considered as fulfilled		
	Environments of intended use of medical equipment in practice (see IEC 60601-1-2 chapt 8.9 figure 3 for definition)		
	Professional healthcare facility environment		
	Operated near active RF-surgery		
	Home healthcare environment		
	Vehicles		
	Aircraft		
	Special environment applicable (see IEC 60601-1-2 chapt 8.9 figure 3)		
	Determination of special Immunity test levels		
Supply Connection:	PUBLIC MAINS NETWORK (e.g. home care ME equipment and ME equipment for doctor's offices in residential areas, should meet the requirements for CISPR 11 class B)		
	Dedicated supply Systems (professional ME equipment e.g. in hospitals or doctor's offices, normally fed by separation transformers, also allowed to meet the requirements for CISPR 11 class A)		
Possible test case verdicts:			
- test case does not apply to the test object:	N/A		
- test object does meet the requirement:	P (Pass)		
- test object does not meet the requirement:	F (Fail)		
Testing:			
Date of receipt of test item:	Mar 12, 2019		
Date (s) of performance of tests:	Mar 12, 2019 to Jul 23,2019		

General remarks:					
"(See Enclosure #)" refers to additional information appended to the report. "(See appended table)" refers to a table appended to the report.					
Throughout this report a \square comma / \boxtimes point is u	sed as the decimal separator.				
Manufacturer's Declaration per sub-clause 4.2.5 of	IECEE 02:				
The application for obtaining a CB Test Certificate includes more than one factory location and a declaration from the Manufacturer stating that the sample(s) submitted for evaluation is (are) representative of the products from each factory has been provided	 ☐ Yes ☑ Not applicable 				
Name and address of factory (ies) Name and address of factory (ies) Ulrichsberger Str. 17 94469 Deggendorf GERMANY					
General product information:					
For test equipment description refer to item 1.1					
Describe any deviations from the Basic EMC standards or from this collateral standard:					
No deviation					
Complementary Information: Calibration of test equipment					
Some calibration of test equipment ran out during the test period. All equipment was calibrated during the test period of each test					

Report	ndex:		
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1.1 Equipment Description

The product is an all-in-one medical panel computer system intended for use in medical environment (hospitals, medical centers, physician's facilities etc.).

The device provides medically relevant information to medical personnel. Patient and / or surgical and medical data are displayed, processed and stored locally or can be exported to external systems.

EUT with basic functionality; the EUT is always at least a combination of the following functions: CPU (Intel i3 or i5 or i7) 2x DDR4 SODIMM sockets LCD panel (21.5" or 23.8" or 27") Internal AC or (optional) external DC PSU PCAP touch or glass front Interfaces as provided by the assembled main board

EUT with basic functionality with add-on (optional) modules; the EUT can have one or more of the following functions:

2.5" SATA HDD/SSD in removable bay M.2 2260 socket for SSD/mPCIe modules M.2 2230 socket for WLAN/Bluetooth modules mPCIe full size socket PCIe raiser card, 16 lanes for PCIe cards Isolated interfaces Backup battery with charger module

Tested configuration: see chapter 1.3



POTENTIAL EQUALIZATION CONDUCTOR USED: Yes No

Note: If yes, include information on connection to the terminal for connection of a POTENTIAL EQUALIZATION CONDUCTOR used during testing, if any, below.

Software and Firmware Version:

MS Windows 10 Operating system (WIN 10 Enterprise 2016 LTSB x64) Passmark Bitpro test suite (8.1 Pro b1025) Test program for frame grabber module (Streamcatcher 1.1.0.175)

Test program for RFID reader (Hterm 0.81) Ping command to access point IP in an OS CMD window

Prototype: Production Version:

Unit(s) Tested (include serial numbers)

MLC8-23 SN:MLC8-23-0001-19

Rationale for number of samples tested: N/A

INTENDED USE:

The product is an all-in-one medical panel computer system intended for use in medical environment (hospitals, medical centers, physician's facilities etc.). The complete wording of the intended purpose is contained in the document ATGD-DMF-MLC8-002_Intended Purpose [insert link] and in the user manual of the device.

The device provides medically relevant information to medical personnel. Patient and / or surgical and medical data are displayed, processed and stored locally or can be exported to external systems. The device is intended to be operated within the scope of the intended purpose by medical personnel working in health care facilities. Furthermore, persons functioning as device administrators are intended to use the device and to maintain the device to the extent described in the according device manual.

The device is neither intended to be operated by, nor intended to be connected directly to patients (unless used as part of a medical system, configured by a third party).

The product is a Medical PC intended for stand-alone use or for usage in conjunction with (other) medical electrical equipment.

The maximum operating ambient temperature is +30°C.

The average service life-time of the device used within the limits of the intended purpose ranges from 3 to in max. 7 years.

The device incorporates the LCD panel and computational elements in one enclosure. All operating controls are located on the lower front side. All connectors (I/O interfaces) are provided at the back-bottom side, underneath the cable cover.

Depending from the product variation, the device is available with or without PCAP (projected capacitive) touch screen functionality.

Manufacturer and applicant of the product is ADLINK Technology GmbH, referenced as ATG. Trademark of the computer is provided on the device marking label.

Intended environments (Specify environment: Professional healthcare facility, HOME HEALTHCARE or SPECIAL (if SPECIAL please describe):

Professional healthcare facility environment

Testing of PERMANENTLY INSTALLED LARGE ME EQUIPMENT OF LARGE ME SYSTEM:		
Yes 🗌 No 🛛		
If Yes, include the following information		
Frequencies tested		
Power levels of RF test sources		
Modulation of RF test sources		
Test distance used		
Other relevant information related to test		

1.1.1 EQUIPMENT Marking Plate

Model: MLC 8-23
S/N: MLC8-23-0001-19
Input Current: 1.5A - 0.75A Frequency: 50/60Hz
Manufactured and assembled in Germany by: ADLINK Technology GmbH Ulrichsberger Str. 17 94469 Deggendorl 2019-03

1.1.2 EUT and Supporting EQUIPMENT Used During Test:

Use*	Product Type	Manufacturer	Model	Comments	
EUT	Panel computer sys.	ADLINK	MLC 8-23		
Note: * Use one of the following (add more rows if needed): EUT - EQUIPMENT Under Test AE – ACCESSORIES/Auxiliary/Associated EQUIPMENT SIM - Simulator (Not Subjected to Test) *Note: Use abbreviations:					

L

1.1.3 SIP/SOP and Input/output Ports:

PORT No.	Name	Туре*	Cable Length	Cable Shielded (Y/N)	Comments (SIP/SOP lines must include description of use) (PATIENT-coupled cable termination must be described) (Interconnecting cables – describe construction details, ferrites, etc.)
0	Enclosure	N/E		—	None
1	Mains	AC			1 pcs
2	Ethernet	SIP/SOP	3m	Y	3 pcs
3	COM port RS232	SIP/SOP	3m	Y	2 pcs
4	USB 3.0 port	SIP/SOP	3m	Y	6 pcs
5	DisplayPort	SOP	3m	Y	2 pcs
6	Line out	SOP	3m	Y	1 pcs
7	Mic in	SIP	3m	Y	1 pcs
Supplementary information:					
*Note					
AC= AC	AC= AC Power PORT		DC = DC Power PORT		Batt=Battery
N/E = Non-Electrical SIP/SOP= SIGNAL IN		SIGNAL INP	UT/OUTPUT F	PORT PC – PATIENT-Coupled Cable	
TP= Te	elecommunication Ports IC = Interconnecting cable				





1.1.4 EUT Internal Operating Frequencies (Optional):

Frequency (MHz)	Description	Frequency (MHz)	Description		
3100	Intel® Core™ i3-8100T CPU	1200	DDR4 DRAM		
3500	Intel® Core™ i5-8500T CPU	100	Bus CLK		
4000	Intel® Core™ i7-8700T CPU	5000	USB 3.0		
6000	SATA 3	480	USB 2.0		
25	Base CLK LAN	0.032768	Base CLK RTC		
24	Base CLK PCH	8	AT90USB646		
2.4	Switching freq. voltage generator	60/72/87.5	21.5" LCD CLK (min/typ/max)		
53.7/71.2/90	23.8" LCD CLK (min/typ/max)	53.7/71.2/90	27" LCD CLK (min/typ/max)		
13.56	RFID reader	2400/5000	WLAN/Bluetooth®		
Supplementary information:					

1.1.5 Power Interface

Mode No.	Voltage (V)	Current (A)	Power (W)	Frequency (DC/AC-Hz)	Phases (No.)	Comments
Rated	100 - 240	1.5 - 0.75		50/60	1	
1	230	0.492	105.2	50	1	
2	100	1.062	105.2	60	1	
3	240	0.473	104.9	50	1	
4	24 VDC					Battery operated If not stated otherwise: power cable attached, but supply voltage turned off

Supplementary information:

Selection of power supply voltage and frequency during tests at equipment

If a test is applicable, it shall be performed using the power input voltages and frequencies specified in the table below. (see IEC 60601-1-2 chapt 4.3.3)

Test Power	input voltage	Line frequency
Mains terminal disturbance voltage (conducted EMISSIONS) CISPR 11	Any one voltage a)	Any one frequency b)
Electromagnetic radiation disturbance (radiated EMISSIONS) CISPR 11	Any one voltage a)	Any one frequency b)
Harmonic current EMISSIONS IEC 61000-3-2	For ME EQUIPMENT and ME SYSTEMS RATED 220 V to 240 V or 380 V to 415 V: If RATED at a single voltage, that voltage. If single-phase and a range is specified, 230 V If three-phase and a range is specified, 400 V	50 Hz or 60 Hz
Voltage changes, voltage fluctuations and flicker EMISSIONS IEC 61000-3-3	For ME EQUIPMENT and ME SYSTEMS RATED 220 V to 250 V line to neutral: If RATED at a single voltage, that voltage. If single-phase and a range is specified, 230 V If three-phase and a range is specified, 400 V	50 Hz
ELECTROSTATIC DISCHARGE IMMUNITY IEC 61000-4-2	Any one voltage a)	Any one frequency b)
Radiated RF electromagnetic field IMMUNITY IEC 61000-4-3	Any one voltage a)	Any one frequency b)
IMMUNITY to proximity fields from RF wireless communications equipment IEC 61000-4-3 (interim method)	Any one voltage a)	Any one frequency b)
Electrical fast transient/burst IMMUNITY – a.c. mains IEC 61000-4-4	Any one voltage a)	Any one frequency b)
Electrical fast transient/burst IMMUNITY – I/O SIP/SOP PORTS IEC 61000-4-4	Any one voltage a)	Any one frequency b)
Surge IMMUNITY IEC 61000-4-5	Any one voltage a)	Any one frequency b)
IMMUNITY to conducted DISTURBANCES induced by RF fields (conducted RF DISTURBANCE IMMUNITY) – a.c. mains	Any one voltage a)	Any one frequency b)

IMMUNITY to conducted DISTURBANCES induced by RF fields (conducted DISTURBANCE IMMUNITY) – SIP/SOP PORTS IEC 61000-4-6	Any one voltage a)	Any one frequency b)
Power frequency magnetic field IMMUNITY IEC 61000-4-8	Any one voltage a)	Either 50 Hz or 60 Hz. During the test, the frequency of the generated magnetic field and the line frequency of the ME EQUIPMENT or ME SYSTEM shall be the same.b)
Voltage dips, short interruptions and voltage variations IMMUNITY IEC 61000-4-11	If the RATED voltage range < 25 % of the lowest RATED input voltage, one RATED input voltage. Otherwise, minimum and maximum RATED voltage c) d)	Any one frequency b)
EQUIPMENT or ME SYSTEM is tested at one po	wer input voltage within the ME EQUIPMENT or ME SYSTEM R wer input voltage, it is not necessary to re-test at additiona e frequency within the ME EQUIPMENT or ME SYSTEM RATED e frequency, it is not necessary to retest at additional frequ	al voltages. frequency range. If the ME
 Examples: The RATED voltage range is 100 V a 240 V a.c 100 V a.c. = 140 V a. 25 % of 100 V a.c. is 25 V a.c. 140 V a.c. > 25 V a.c. Therefore, the ME EQUIPMENT or M 		oltage.
 The RATED voltage range is 220 V a 240 V a.c. – 220 V a.c. = 20 V a.c 25 % of 220 V a.c. is 55 V a.c. 20 V a.c. < 55 V a.c. Therefore, the ME EQUIPMENT or M 		

d) ME EQUIPMENT and ME SYSTEMS with power input voltage selection by transformer taps shall be tested at only one tap setting.

1.2 EUT Operation Modes:

Mode #	Description
1	EUT unpowered, power cable removed (not tested, no emissions expected)
2	EUT power cable attached, standby mode (not tested, no emissions expected)
3	EUT powered and booted, idle/desktop mode (not tested, emissions expected lower than worst case modes)
4	EUT powered and booted, executing system test (not tested, emissions expected lower than worst case modes)
5	EUT powered and booted, power cable attached to provide PE connection, but supply voltage turned off \rightarrow discharging internal UPS battery, executing system test (worst case mode – discharging)
6	EUT powered and booted, power cable attached, charging internal UPS battery, executing system test (worst case mode – charging)
Supplemen	tary information:

1.3 EUT Configuration Modes:

Configuration #	Description
1	Intel® i7-8700T CPU
	2x8GB DDR4 2400 RAM modules
	• 23.8" FullHD LCD
	AC input for internal SMPS
	Glass front
	• 2.5" SATA SSD 128GB
	• M.2 2260 SSD 128GB
	M.2 2230 frame grabber module
	miniPCle RFID module
	PCIe Gigabit LAN card
	2x OptoCom RS232
	Backup battery with charger module
Supplementary int to perform the test	formation (include any special ME EQUIPMENT or ME SYSTEM hardware or software needed ts).

1.4 BASIC SAFETY, ESSENTIAL PERFORMANCE and Pass/Fail Criteria as determined by the Manufacturer

Description of BASIC SAFETY and ESSENTIAL PERFORMANCE

EC 60601	Description
clause	
	Requirements derived from IEC 60601
8.4	Limitation of voltage, current or energy
8.6	Protective earthing, functional earthing and potential equalization of ME EQUIPMENT
8.7	LEAKAGE CURRENTS and PATIENT AUXILIARY CURRENTS
8.8	Insulation
11.1	Excessive temperatures in ME EQUIPMENT

MLC8 devices itself do not provide any essential performance, shall be evaluated in the end-use product

Description how the BASIC SAFETY and ESSENTIAL PERFORMANCE were monitored during each test

Basic Safety was checked before and after EMC Tests. Basic Safety requirements are meet. No excessive temperatures are observed. (smoke, etc). Basic safety after all immunity tests is evaluated in the report according to IEC 60601-1: N40P0001

IMMUNITY Pass/Fail Criteria				
Test Description	Pass/Fail Criteria description	Part 2 reference		
Electrostatic Discharges		NA		
Radiated RF EM Fields		NA		
Proximity Wireless fields		NA		
Electrical Fast Transients and bursts		NA		
Surges		NA		
Conducted Disturbances, induced by RF fields		NA		
Voltage Dips and Interruptions		NA		
Rated Power-frequency Magnetic Field		NA		

Note: Specific, detailed **IMMUNITY** pass/fail criteria, shall be based on applicable part two standards or RISK MANAGEMENT, for **IMMUNITY** with regard to EM DISTURBANCES. These pass/fail criteria shall be included in the RISK MANAGEMENT FILE

IMMUNITY TEST LEVELS for SPECIAL ENVIRONMENTS			
EM DISTURBANCE levels	Test Level	Justification for SPECIAL ENVIRONMENTS identified	
Conducted RF EMISSIONS		NA	
Radiated RF EMISSIONS		NA	
Harmonic Distortion		NA	
Voltage Fluctuations and Flicker		NA	
IMMUNITY TEST LEVELS		NA	
Electrostatic Discharges		NA	
Radiated RF EM Fields		NA	
Proximity Wireless fields		NA	
Electrical Fast Transients and bursts		NA	
Surges		NA	
Conducted Disturbances, induced by RF fields		NA	
Voltage Dips and Interruptions		NA	
Rated Power-frequency Magnetic Field		NA	

Supplemental Information:

- The resulting final IMMUNITY TEST LEVELS are to be rounded to the nearest whole number or, if a decimal, to a single significant digit
- Details of the methods and data sources used in determining the appropriate IMMUNITY TEST LEVELS are to be described in the table below.

IMMUNITY	Details of the methods and data sources used in determining the appropriate IMMUNITY TEST LEVELS noted above
Electrostatic Discharges	NA
Radiated RF EM Fields	NA
Proximity Wireless fields	NA
Electrical Fast Transients and bursts	NA
Surges	NA
Conducted Disturbances, induced by RF fields	NA
Voltage Dips and Interruptions	NA
Rated Power-frequency Magnetic Field	NA

1.5 Configuration Block Diagram:

None

1.6 Compliance Summary

	Manual_MLC 8_rev 0.7_en, Release date 30.01.2019, Rev 0.7 – Preliminary ATGD-DMF-MLC8-002_Intended Purpose_1.0, Version 1
List of ACCOMPANYING	
DOCUMENTS reviewed	

IEC 60601-1-2						
Clause	Requirement + Test	Result - Remark	Verdict			
4	GENERAL REQUIREMENTS					
4.1	RISKS resulting from reasonably foreseeable ELECTROMAGNETIC DISTURBANCES taken into account in the RISK MANAGEMENT PROCESS.	RMF Reference Document: Document ATGD-DMF-MLC8-008, 'product risk analysis', # 29 – # 34	Р			
4.2	Non-ME EQUIPMENT used in an ME SYSTEM		N/A			
	Check 16.1 of general standard, checked by inspection of the RISK MANAGEMENT FILE and	RMF Reference Document:	N/A			

4.2	Non-ME EQUIPMENT used in an ME SYSTEM		N/A
	Check 16.1 of general standard, checked by inspection of the RISK MANAGEMENT FILE and OBJECTIVE EVIDENCE of compliance with the respective EMC standards, or by the tests of this collateral standard	RMF Reference Document: ATGD-DMF-MLC8-002 'description of the intended purpose', section 4.2; manual, chapter 4.1.2	N/A
	non-ME EQUIPMENT used in an ME SYSTEM complies with IEC and ISO EMC standards applicable to that EQUIPMENT, checked by inspection of the RISK MANAGEMENT FILE and OBJECTIVE EVIDENCE of compliance with the respective EMC standards, or by the tests of this collateral standard	See above	N/A
	non- ME EQUIPMENT used in an ME SYSTEM for which the intended EM ENVIRONMENT could result in the loss of BASIC SAFETY OF ESSENTIAL PERFORMANCE of the ME SYSTEM due to the non-ME EQUIPMENT tested according to the requirements of this collateral standard, checked by inspection of the RISK MANAGEMENT FILE and OBJECTIVE EVIDENCE of compliance with the respective EMC standards, or by the tests of this collateral standard	See above	N/A
4.3.1	Configurations		Р
	ME EQUIPMENT and ME SYSTEMS tested in representative configurations, consistent with INTENDED USE, that are most likely to result in unacceptable RISK as determined by the MANUFACTURER (This was determined using RISK ANALYSIS, experience, engineering analysis, or pretesting). Compliance checked by inspection of the test report and the RISK MANAGEMENT FILE.	See Appended Item Table 1.3 and RMF Reference Document: Considerations and documentation of the representative configurations are described in ATGD_MLC8_EMC_Testplan_1.2, chapter 3.1 Test plan is part of RMF, see reference document "ATGD-DMF- MLC8-011_internal note EMC test plan_1.0"	Ρ
4.3.3	Power input and frequencies	See appended Table Item 1.1.5	Р
5	IDENTIFICATION, MARKING AND DOCUMENTS		
5.1	Additional requirements for marking on the outside of ME EQUIPMENT and ME SYSTEMS specified for use only in a shielded location SPECIAL ENVIRONMENT		

	IEC 60601-1-2			
Clause	Requirement + Test	Result - Remark	Verdict	
	-			
	ME EQUIPMENT and ME SYSTEMS specified for use only in a shielded location SPECIAL ENVIRONMENT labelled with a CLEARLY LEGIBLE warning that they should be used only in the specified type of shielded location		N/A	
5.2	ACCOMPANYING DOCUMENTS			
5.2.1	Instructions for use			
5.2.1.1	General			
a)	A statement of the environments for which	RMF Reference Document:	Р	
	the ME EQUIPMENT OR ME SYSTEM is suitable. Relevant exclusions determined by RISK ANALYSIS, are listed.	See reference document, Manual_MLC 8_rev 0.7_en, Release date 30.01.2019, Rev 0.7 – Preliminary, Chapter 10.1.2.		
		This document will be referred as IFU further in this report		
b)	The ESSENTIAL PERFORMANCE of ME EQUIPMENT and a description of what the operator can expect if the ESSENTIAL PERFORMANCE is lost or degraded due to EM disturbances.	No essential performance defined by the manufacturer. See reference document, ATGD- DMF-MLC8-008_RA MLC8_draft_0.6, chapter 4.2	N/A	
c)	A warning regarding stacking and location close to other EQUIPMENT	See Document "ATGD-DMF- MLC8-002_Intended Purpose_1.0", Chapter 10.1	Р	
d)	List of cables, transducers and accessories	See Document "ATGD-DMF- MLC8-002_Intended Purpose_1.0", Chapter 10.1	N/A	
		The only recommendation is to use shielded cables and observe the vendors bend radius. Therefore a list of cables is not applicable.		
e)	A warning that other cables and accessories may negatively affect EMC performance	No accessories, transducers or cables provided by manufacturer; no restrictions defined	N/A	
f)	A statement that portable RF communications EQUIPMENT including antennas, can effect medical electrical EQUIPMENT. The warning includes a use distance such as "be used no closer than 30 cm (12 inches) to any part of the [ME EQUIPMENT or ME SYSTEM], including cables specified by manufacturer"	See IFU, Chapter 10.1	Ρ	
5.2.1.2	Requirements applicable to ME EQUIPMENT and according to CISPR 11	ME SYSTEMS classified class A	Р	

	IEC 60601-1-2			
Clause	Requirement + Test	Result - Remark	Verdict	
		L	1	
	FOR ME EQUIPMENT and ME SYSTEMS that are classified as class A according to CISPR 11, the instructions for use include the following note:	See IFU, Chapter 10.1	Р	
	NOTE: "The EMISSIONS characteristics of this equipment make it suitable for use in industrial areas and hospitals (CISPR 11 class A). If it is used in a residential environment (for which CISPR 11 class B is normally required) this equipment might not offer adequate protection to radio-frequency communication services. The user might need to take mitigation measures, such as relocating or re-orienting the equipment."			
5.2.2	Technical description			
5.2.2.1	Requirements applicable to all ME EQUIPMENT a	ND ME SYSTEMS		
	The technical description describes precautions to be taken to prevent adverse events to the PATIENT and Operator due to electromagnetic disturbances	Reference Document: See IFU, Chapter 10, caution passage	P	
a)	Compliance for each EMISSIONS and IMMUNITY standard or test specified by this collateral standard, e.g. EMISSIONS class and group and IMMUNITY TEST LEVEL	See IFU, Chapter 10.1	P	
b)	Any deviations from this collateral standard and allowances used	Reference Document: No deviations or allowances specified	Р	
c)	All necessary instructions for maintaining BASIC SAFETY and ESSENTIAL PERFORMANCE with regard to ELECTROMAGNETIC DISTURBANCES for the EXPECTED SERVICE LIFE	See IFU, Chapter 6.5.1 No maintenance or service intervals required Chapter 10.1 notice	P	
5.2.2.2	Requirements applicable to ME EQUIPMENT spece	cified for use only in shielded location	SPECIAL	
	The technical description includes the following	information:		
a)	A warning to the effect that: WARNING: Failure to use this EQUIPMENT in the specified type of shielded location could result in degradation of performance, interference with other equipment or interference with radio services		N/A	
b)	Specifications for shielded location including: – minimum RF shielding effectiveness; – for each cable that enters or exits the shielded location, the minimum RF filter attenuation; and – the frequency range(s) over which the specifications apply		N/A	

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Clause	Requirement + Test		Result - Remark	Verdict

c)	Test methods for measurement of RF shielding effectiveness and RF filter attenuation		N/A	
d)	One or more of the following and a recommendation that a notice containing this information be posted at the entrance(s) to the shielded location:		N/A	
	 a specification of the EMISSIONS characteristics of other EQUIPMENT allowed inside the shielded location with the ME EQUIPMENT or ME SYSTEM; 			
	 – a list of specific EQUIPMENT allowed; – a list of types of EQUIPMENT prohibited. 			
5.2.2.3	Requirements applicable to ME EQUIPMENT that intentionally receive RF electromagnetic energy include the following information - each frequency or frequency of reception,	Reference Document: See IFU, Chapter 6.4.2	Р	
	- the preferred frequency or frequency band, if applicable, and			
	- the bandwidth of the receiving section of the ME Equipment in those bands			
5.2.2.4	Requirements applicable to the ME EQUIPMENT that include RF transmitters the technical description includes the frequency or frequency band of transmission, the type and frequency characteristics of the modulation and the EFFECTIVE RADIATED POWER (ERP)	Reference Document: See IFU, Chapter 6.4.2	Ρ	
5.2.2.5	Requirements applicable to PERMANENTLY INSTA	ALLED LARGE ME EQUIPMENT and LARGE	ME	
	The technical description includes the following information:			
a)	A statement that an exemption has been used and that the EQUIPMENT has not been tested for radiated RF IMMUNITY over the entire frequency range 80 MHz to 6 GHz		N/A	
b)	WARNING: "This EQUIPMENT has been tested for radiated RF IMMUNITY only at selected frequencies, and use nearby of emitters at other frequencies could result in improper operation"		N/A	
c)	A list of the frequencies and modulations used to test the IMMUNITY of the ME EQUIPMENT or ME SYSTEMS		N/A	
5.2.2.6	Requirements applicable to ME EQUIPMENT that EQUIPMENT	claim compatibility with HF Surgical	N/A	
	Technical description includes a statement of HF SURGICAL EQUIPMENT compatibility and the conditions of INTENDED USE during HF Surgery		N/A	

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Clause	Requirement + Test		Result - Remark	Verdict

6.1	Documentation of tests - General		
	The documentation of tests contains all information necessary to facilitate adequate planning (test plan) and execution of tests	all information necessary is included in this test report	Р
6.2	Test Plan		1
	Prior to the start of formal testing, a detailed test plan provided to the test laboratory. (Note: title / name / version of test plan in remark section)	See Test Plan ATGD_MLC8_EMC_Testplan_1.3	Ρ
7	Electromagnetic EMISSIONS requirements f	or ME EQUIPMENT and ME SYSTE	MS
7.1.1	Protection of radio services and other equipmer		Р
	Unless otherwise specified herein, ME EQUIPMENT and ME SYSTEMS complies with CISPR 11		Р
7.1.2	Operating modes		Р
	During Emission testing, ME EQUIPMENT or ME SYSTEM tested in the modes that maximize Emissions. In addition to active modes, the inclusion of standby mode was considered. The operating modes selected for testing documented in the test plan and documented in the test report	See Appended Item Table 1.2	Ρ
7.1.3	Multimedia Equipment		N/A
	Multimedia equipment connected to ME EQUIPMENT or ME SYSTEM complies with CISPR 32. If CISPR 32 class A equipment is supplied as part of the ME SYSTEM classified class A		N/A
7.1.4	Subsystems		N/A
	Compliance with CISPR 11 demonstrated by testing each subsystem of an ME SYSTEM on a subsystem basic, provided the requirements of CISPR 11 for evaluation of EQUIPMENT that interacts with other equipment to form a system are met		N/A
7.1.5	ME EQUIPMENT and ME SYSTEMS specified for use ENVIRONMENT	e only in a shielded location SPECIAL	N/A

	IEC 60601-1-2			
Clause	Requirement + Test	Result - Remark	Verdict	
	For ME EQUIPMENT and ME SYSTEMS that are specified for use only in a shielded location SPECIAL ENVIRONMENT, the electromagnetic radiation disturbance limits of CISPR 11 may be increased, when tests are performed on a test site, by an amount up to the applicable specified value of minimum RF shielding effectiveness, provided the minimum RF shielding effectiveness specification		N/A	
	For ME EQUIPMENT and ME SYSTEMS that are specified for use only in a shielded location SPECIAL ENVIRONMENT, the mains terminal disturbance voltage limits of CISPR 11 may be increased, when tests are performed on a test site, by an amount up to the applicable specified value of minimum RF filter attenuation for all cables that enter or exit the shielded location, provided the minimum RF filter attenuation specification		N/A	
a)	The specified RF shielding effectiveness and RF filter attenuation: - expressed in dB; - rounded to the nearest integer; and - at least 20 dB		N/A	
b)	The RF shielding effectiveness and RF filter attenuation specification include the frequency range over which the RF shielding effectiveness and RF filter attenuation apply, and this frequency range is at least one decade in width	Reference to Document:	N/A	
c)	The specified value(s) for minimum RF filter attenuation are identical to the specified value(s) for minimum RF shielding effectiveness in each frequency range for which they are specified	Reference to Document:	N/A	
d)	In frequency ranges for which the minimum RF shielding effectiveness and RF filter attenuation are not specified or are specified to be less than 20 dB, the RF shielding effectiveness and RF filter attenuation assumed to be 0 dB for the purpose of this collateral standard	Reference to Document:	N/A	
7.1.6	ME EQUIPMENT and ME SYSTEMS that include r	adio equipment	N/A	

IEC 60601-1-2			
Clause	Requirement + Test	Result - Remark	Verdict

8	Electromagnetic IMMUNITY requirements for	or ME EQUIPMENT and ME SYSTEM	S
	Emission limits per environment	See Appended Item Tables 1.8 to 1.10	Р
7.3	Emissions requirements summary		Р
	If the ME EQUIPMENT AND ME SYSTEMS has a PUBLIC MAINS NETWORK it complies with the requirements of IEC 61000-3-3.	See Appended Item Table 1.12	Ρ
7.2.2	Voltage fluctuations and flicker		Р
	If the ME EQUIPMENT OR ME SYSTEMS has a PUBLIC MAINS NETWORK it complies with the requirements of IEC 61000-3-2	See Appended Item Table 1.11	Ρ
7.2.1	Harmonic distortion		Р
7.2	Protection of the PUBLIC MAINS NETWORK		Р
	TEST METHOD SELECTED		N/A
	PERMANENTLY INSTALLED LARGE ME EQUIPMENT and LARGE ME SYSTEMS was TYPE TESTED by at least one of the following methods: - on a test site as a system; - on a test site on a subsystem basis; - <i>in situ</i> as a system at the premises of a RESPONSIBLE ORGANIZATION		N/A
7.1.12	PERMANENTLY INSTALLED LARGE ME EQUIPMENT &	and LARGE ME SYSTEMS	N/A
	For diagnostic X-ray generators and ME SYSTEMS that include X-ray generators operating in INTERMITTENT MODE, the quasi- peak limits to discontinuous radiated and conducted DISTURBANCES can be relaxed by 20 dB		N/A
7.1.8	ME EQUIPMENT and ME SYSTEMS containing X-ra	ay generators	N/A
	ME EQUIPMENT whose main functions are performed by motors and switching or regulating devices may be classified in accordance with CISPR 14-1		N/A
7.1.7	ME EQUIPMENT whose main functions are performed regulating devices	rmed by motors and switching or	N/A
	ME EQUIPMENT and ME SYSTEMS that include radio equipment (e.g. RF transmitters, receivers, transceivers) and have been tested together with the radio equipment and found to comply with applicable national radio regulations are exempt from testing to CISPR ELECTROMAGNETIC DISTURBANCE requirements		N/A

IEC 60601-1-2				
Clause	Clause Requirement + Test Result - Remark			
	For ME EQUIPMENT and ME SYSTEMS for which		N/A	

	For ME EQUIPMENT and ME SYSTEMS for which the INTENDED USE includes types of transportation or other locations as in the <u>HOME HEALTHCARE ENVIRONMENT</u> if additional IMMUNITY tests or IMMUNITY TEST LEVELS that are higher these additional tests to these higher IMMUNITY TEST LEVELS are documented		N/A
	ME EQUIPMENT OR ME SYSTEMS INTENDED FOR USE IN THE EMERGENCY MEDICAL SERVICES ENVIRONMENT for the HOME HEALTHCARE ENVIRONMENT. If locations in the <u>EMERGENCY</u> <u>MEDICAL SERVICES ENVIRONMENT</u> are identified for which the specifications are for the HOME HEALTHCARE ENVIRONMENT are not adequate, then Annexe E may be used to determine appropriate IMMUNITY TEST LEVELS		N/A
	Before IMMUNITY testing begins, the MANUFACTURER determined specific, detailed IMMUNITY Pass/Fail criteria, based on applicable part two standards or RISK MANAGEMENT, for BASIC SAFETY and ESSENTIAL PERFORMANCE with regard to EM DISTURBANCES. The Pass/Fail criteria and the monitoring specification are included in the test plan, in the test report and in the RISK MANAGEMENT FILE	RMF Reference Document: Documentation in ATGD_MLC8_EMC_Testplan_1.2, chapter 3.5.1 and ATGD-DMF-MLC8-008, 'product risk analysis', # 29 – # 31	Ρ
8.2	PATIENT physiological simulation		N/A
	If a PATIENT simulation is required to verify normal operation of the ME EQUIPMENT or ME SYSTEM, it was provided during IMMUNITY testing		N/A
	Prior to the beginning of the test, the amplitude of simulated PATIENT physiological signals were adjusted to be consistent with normal operation of the ME EQUIPMENT or ME SYSTEM, as specified by the MANUFACTURER		N/A
8.5	Subsystems		N/A
	When subsystems are tested to demonstrate compliance normal operating conditions are simulated		N/A
	The RISK MANAGEMENT PROCESS used to determine whether subsystem testing is allowed.		N/A
8.6	PERMANENTLY INSTALLED LARGE ME EQUIPMENT	and LARCE ME SYSTEMS	N/A

IEC 60601-1-2			
Clause	Requirement + Test	Result - Remark	Verdict

	PERMANENTLY INSTALLED LARGE ME EQUIPMENT TESTED by at least one of the following method		N/A
	 on a test site as a system; on a test site on a subsystem basis; <i>in situ</i> as a system at the premises of a RESPONSIBLE ORGANIZATION 		N/A
	Test Method selected		N/A
8.7	Operating Modes		Р
	Operating Modes and settings	See Appended Item Table 1.4 and RMF Reference Document: Operating modes during testing are determined in ATGD_MLC8_EMC_Testplan, chapter 3.2.2	Ρ
8.8	Non-ME EQUIPMENT		N/A
	Non-ME EQUIPMENT (e.g. ITE) that is a part of an ME SYSTEM fulfils the pass/fail criteria and IMMUNITY TEST LEVELS of Clause 8 if it has been determined, as a result of the RISK MANAGEMENT PROCESS, that the non-ME EQUIPMENT could affect the BASIC SAFETY or ESSENTIAL PERFORMANCE of the ME SYSTEM. (Inspection of the test report and the RISK MANAGEMENT FILE).		N/A
8.9	IMMUNITY TEST LEVELS	No EM disturbance levels altering from basis immunity levels determined	N/A
	Immunity Test Levels based on environment location of Intended Use		N/A
8.10	Immunity to proximity fields from RF wireless of	communication equipment	N/A
	Enclosure Port of ME EQUIPMENT and ME SYSTEMS tested as specified in Table 9 as per IEC 61000-4-3		N/A
Supplem	ental Information: References	,	
	al_MLC 8_rev 0.7_en, Release date 30.01.2019, F nded Purpose_1.0, Version 1	Rev 0.7 – Preliminary ATGD-DMF-MLC	8-

[2] ATGD-DMF-MLC8-008_RA MLC8_draft_0.6, Version 0.6

[3] ATGD_MLC8_EMC_Testplan_1.3, Version 1.3

ATGD-DMF-MLC8-011_internal note EMC test plan_1.0, Version 0.6 ATGD-DMF-MLC8-002_Intended Purpose_1.0, version 1

1.7 Result Summary

Requirement – Test	Result/Comments	Verdict
Clause 7 - EMISSIONS		Р
Classification		
Class A or B:	Class B	
Group 1 or 2:	Group 1	—
CISPR 11, 14-1, or ISO 7137:	CISPR 11	—
Conducted RF EMISSIONS		Р
Radiated RF EMISSIONS		Р
Disturbance Power (if applicable):		N/A
Harmonic Distortion per IEC 61000-3-2 (Class A, B, C, D) :	Class A	Р
Voltage Fluctuations and Flicker per IEC 61000-3-3:		Р
Clause 8 - IMMUNITY		Р
Electrostatic Discharges:		Р
Radiated RF EM Fields:		Р
Radiated RF EM Fields and Proximity Wireless fields:		Р
Electrical Fast Transients and bursts:		Р
Surges:		Р
Conducted Disturbances, induced by RF fields:		Р
Voltage Dips and Interruptions:		Р
Rated Power-frequency Magnetic Field:		Р
Supplemental Information: If tests are not performed, provide rat	ionale here for each test:	
Not applicable		
If applicable, describe methods used to reduce the impact of am	bient:	

Not applicable

Deviations from the Basic EMC standards or from this collateral standard				
Test Description of Deviation				
Not applicable				

1.8 Test Conditions and Results – Conducted EMISSIONS

CISPR 11: 2009 +A1: 2010	TEST: Limits of	main	ns terminal disturban	ce voltage		Verdic
		_				Р
Laboratory Param	eters		Required prior to	During the test		
Ambient Temperat	ture		10 to 40 °C		23.	7 °C
Relative Humidity			10 to 90 %		31.	1 %
Fully configured s		Freq	luency range on eacl	h side of line	Measuremen	t Point
over the following range	Trequency		150 kHz to 30 I	VHz	Ма	ins
		Pow	er interface mode		4,	1
EQUIPMENT mode)	EUT	configurations mod	e		1
		Ope	ration mode		5,	6
		Li	mits – Group 1 - Clas	s A		
			Limit d	IB (μV)		
Frequency (MHz)	Quasi-Peak	:	Result*	Average		Result*
0.15 to 0.50	79		N/A	66		N/A
0.50 to 30	73		N/A	60		N/A
		Li	mits - Group 2 - Clas			
			Limit d			
Frequency (MHz)	Quasi-Peak		Result*	Average		Result*
0.15 to 0.50		100 N		90		N/A
0.50 to 5	86		N/A	76		N/A
5 to 30	90 to 70	N/A 80 to 60			N/A	
	Mains		mits - Group 2 - Clas y currents in excess of 10			
			Limit d	IB (μV)	-	
Frequency (MHz)	Quasi-Peak	[Result*	Average		Result*
0.15 to 0.50	130		N/A	120	N/A	
0.50 to 5	125		N/A	115		N/A
5 to 30	115		N/A	105		N/A
		Limit	s - Group 1 and 2 - C			
			Limit d			
Frequency (MHz)	Quasi-Peak		Result*	Average		Result*
0.15 to 0.50	66 to 56		Р	56 to 46		Р
0.50 to 5	56		Р	46		Р
5 to 30	60		Р	50		Р

CISPR 14-1: 2005 TEST: Limits of terminal disturbance voltage	Verdict
	N/A
Supplementary information: * - The result in this table may be a minimum margin to the limit. EUT powered at one of the Nominal input voltages and frequencies.	

Note 1: the World Administrative Radio-Communications Conference (WARC) has in 1979 reduced the lower frequency limit in region 1 to 148.5 kHz; for applications falling in the scope of this standard, tests at 150 kHz are considered adequate, since 148.5 kHz falls within the receiver bandwidth. In limit tables 150 kHz used.

ISO 7137: 1995	TEST: Limits of mains terminal and I/O disturbance current	Verdict
		N/A
	mation: * - The result in tables may be a minimum margin to the limit. e of the Nominal input voltages and frequencies.	

Test equipment used for Mains Terminal Disturbance Voltage

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0339	test chamber 4	Siemens			chk	Feb 22, 2019	Feb 2020
	LISN (integrated pulse limiter P0490)	R&S	ESH3-Z5	829567/009	cal	Apr 02, 2019	Apr 2021
P1915	Data logger for humidity and temperature (MZ4)	testo AG	testo 175 H1	40342591	cal	Aug 19, 2017	Aug 2020
P0320	EMI receiver, MZ4	R&S	ESCS30	100099	cal	Apr 05, 2018	Apr 2020
P1325	EMI receiver	R&S	ESPI-3	101500	cal	Apr 08, 2019	Apr 2021
P1891	RF-Relais-Matrix	R&S	PSU	872584/018	cnn		

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance

Photo of test setup for Mains Terminal and Input / Output Disturbance Voltage





Tabulated Results for Mains Terminal Disturbance Voltage – operation mode 6

Frequency	OuasiPeak	Average	Limit	Margin	Meas. Time	Bandwidth	Line	PE	Corr.
(MHz)	(dBµV)	(dBµV)	(dBµV)	(dB)	(ms)	(kHz)	Line		(dB)
0.170000		32.14	54.96	22.82	1000.0	9.000	L1	GND	10
0.182000	56.45		64.39	7.94	1000.0	9.000	Ν	GND	10
0.186000		36.51	54.21	17.70	1000.0	9.000	Ν	GND	10
0.222000		38.18	52.74	14.56	1000.0	9.000	Ν	GND	10
0.366000		30.52	48.59	18.07	1000.0	9.000	L1	GND	10
0.374000	43.89		58.41	14.52	1000.0	9.000	L1	GND	10
0.374000		29.44	48.41	18.97	1000.0	9.000	L1	GND	10
0.430000	39.78		57.25	17.47	1000.0	9.000	L1	GND	10
0.602000	38.92		56.00	17.08	1000.0	9.000	Ν	GND	10
1.210000	42.17		56.00	13.83	1000.0	9.000	L1	GND	10
13.562000		52.20	*	*	1000.0	9.000	Ν	GND	11
13.562000	52.07		*	*	1000.0	9.000	Ν	GND	11

*) Note: limit not applicable to wanted RFID carrier at 13.56 MHz



Tabulated Results for Mains Terminal Disturbance Voltage - operation mode 5

	Frequency	QuasiPeak	Average	Limit	Margin	Meas. Time	Bandwidth	Line	PE	Corr.
	(MHz)	(dBµV)	(dBµV)	(dBµV)	(dB)	(ms)	(kHz)			(dB)
Ī	13.562000		52.50	*	*	1000.0	9.000	Ν	GND	11
	13.562000	52.01		*	*	1000.0	9.000	L1	GND	11
	13.886000		16.26	50.00	33.74	1000.0	9.000	L1	GND	11
	13.894000		13.18	50.00	36.82	1000.0	9.000	Ν	GND	11
	14.214000		19.38	50.00	30.62	1000.0	9.000	Ν	GND	11
	14.530000		17.12	50.00	32.88	1000.0	9.000	L1	GND	11

*) Note: limit not applicable to wanted RFID carrier at 13.56 MHz



1.9 Test Conditions and Results – Radiated EMISSIONS

CISPR 11: 2009 +A1: 2010 TEST:	Limits for radiated	disturbance ().15 MHz –1 GHz	Verdict		
Test site: OATS			Alternative Test Site	Р		
Laboratory Parameters:	Required prior	to the test	During the test			
Ambient Temperature	10 to 40	°C	20 °C			
Relative Humidity	10 to 90	%	25 %			
Fully configured sample scanned	Frequency	range	Measurement Dista	nce		
over the following frequency range	e 🗌 0.15 MHz	– 1 GHz	🗌 3 m 🗌 10 m			
	🖂 30 MHz -	- 1 GHz	🖂 3 m 🖂 10 m			
	Power interface r	node	4			
EQUIPMENT mode	EUT configuratio	ns mode	1			
	Operation mode		5 (at 10 m), 6 (at 3	m)		
	Limits – Group 1 Class A					
		Limit dB (µV/m)				
Frequency (MHz)	Quasi-P	Quasi-Peak Result				
30 to 230	40		N/A			
230 to 1000	47	47				
	Limits – Group 1					
Frequency (MHz)	Limit dB (µV/m)					
	Quasi-P	еак	Results *			
30 to 230	30 ¹		P			
230 to 1000	372		Р			
	Limits – Group 2		(Λ/m) , Λ hove 20MHz dP (1//m)		
Frequency (MHz)	Quasi-P		A/m); Above 30MHz dB (µ Results *	v/m)		
0.15 to 30	See stand		N/A			
30 to 1000	See stan		N/A			
	Limits – Group 2					
			A/m); Above 30MHz dB (µ	IV/m)		
Frequency (MHz)	Quasi-Peak	Average**	Results *	,		
0.15 to 30	39 to 3***	-	N/A			
30 to 80.872	30	25	N/A			
80,872 to 81,848	50	45	N/A			
81,848 to 134,786	30	25	N/A			
134,786 to 136,414	50	45	N/A			
136,414 to 230	30	25	N/A			
230 to 1000	37	32	N/A			

	IEC 60601-1-2							
Supp * ** ***	- The Average Limits Apply To Magnetion Driven Equipment Only.							
QP L	imit for Measureme	ent distance at 3m						
		Class A	Class B					
1	30 to 230	50 dB (µV/m)	40 dB (μV/m)					
2	230 to 1000	57 dB (µV/m)	47 dΒ (μV/m)					
Note	: In battery mode:	power cable attached	, but supply voltage turned off					
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CISPR 11: 200	9 +A1: 2010	TEST: Limits for radiated dis	Verdict	
Test site:	OATS	SAC	Alternative Test Site	N/A
* - The res	sult in this table may b	red at one of the Nominal input volta e a minimum margin to the limit. h a resolution bandwidth of 1 MHz a		
		not Group 2 equipment Group 2 equipment but does no	ot operate over 400 MHz.	

ISO 7137: 1995 TEST: Limits for radiated disturbance 100 MHz –6 GHz	Verdict
	N/A
Supplementary information: EUT powered at one of the Nominal input voltages and frequencies. * -The result in this table may be a minimum margin to the limit.	

Test equipment used – operation mode 5

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0336	test chamber 1	Siemens			chk	Feb 22, 2019	Feb 2020
P1352	antenna, Ultralog	R&S	HL562	100413	cal	Jun 06, 2019	Jun 2021
P1139	Mast	innco GmbH	MA 4000	MA4000/083/91311104/L	cnn		
P1912	Data logger for humidity and temperature (MZ1)	testo AG	testo 175 H1	40342580	cal	Aug 18, 2017	Aug 2020
P1140	Controller	innco GmbH	CO 3000	CO3000/916	cnn		
P2062	EMI receiver	R&S	ESR26	101417	cal	Feb 07, 2018	Feb 2020

Test equipment used – operation mode 6

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0338	test chamber 3	Siemens			chk	Feb 22, 2019	Feb 2020
P0311	antenna	Chase	CBL6111	2409	cal	Mar 30, 2018	Mar 2021
P1303	Mast (MZ3)	innco GmbH	MA 4660-XPET		cnn		
P1326	EMI receiver	R&S	ESU26	100058	cal	Apr 05, 2018	Apr 2020
P1304	Controller	innco GmbH	CO 3000	CO3000/915	cnn		
P1914	Data logger for humidity and temperature (MZ3)	testo AG	testo 175 H1	40342576	cal	Aug 19, 2017	Aug 2020

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Tabulated Results for Radiated Disturbance - Operation mode 5

Frequency	QuasiPeak	Limit	Margin	Meas. Time	Bandwidth	Height	Pol	Azimuth	Corr.
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(ms)	(kHz)	(cm)		(deg)	(dB/m)
57.079167	17.24	30.00	12.76	15000.0	120.000	348.0	V	305.0	6
57.725833	19.12	30.00	10.88	15000.0	120.000	288.0	V	291.0	6
58.372500	14.70	30.00	15.30	15000.0	120.000	378.0	V	298.0	6
83.592500	23.35	30.00	6.65	15000.0	120.000	150.0	V	327.0	9
192.475000	24.31	30.00	5.69	15000.0	120.000	100.0	V	319.0	9
295.254583	23.31	37.00	13.69	15000.0	120.000	109.0	V	195.0	13
451.545833	26.88	37.00	10.12	15000.0	120.000	173.0	Н	304.0	17
600.036667	34.36	37.00	2.64	15000.0	120.000	341.0	Н	16.0	20



IEC (60601	-1-2
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Tabulated Results for Radiated Disturbance - Operation mode 6

Frequency (MHz)	QuasiPeak (dBµV/m)	DET 2 (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
112.672500	34.18		40.00	5.82	1000.0	120.000	109.0	V	271.0	12
146.962000	31.74		40.00	8.26	1000.0	120.000	103.0	v	0.0	12
296.667000	30.70		47.00	16.30	1000.0	120.000	158.0	v	332.0	14
450.732000	37.94		47.00	9.06	1000.0	120.000	100.0	v	0.0	18
451.662000	40.06		47.00	6.94	1000.0	120.000	112.0	v	0.0	18
599.992000	42.99		47.00	4.01	1000.0	120.000	197.0	н	322.0	22
999.980000	40.00		47.00	7.00	1000.0	120.000	102.0	v	150.0	27



1.10 Test Conditions and Results – Disturbance Power EMISSIONS

CISPR 14-1: 2005 TEST: Limits of disturbance power	Verdict
	N/A
Supplementary information: * - The result in this table may be a minimum margin to the limit.	
EUT powered at one of the Nominal input voltages and frequencies.	

1.11 Test Conditions and Results – Harmonic Current Emissions

IEC 61000-3-2:2005 +A1: 2008 +A2: 2009	TEST: Limits for harmonic current emis input current ≤ 16 A per phase)	Verdict		
			Р	
Laboratory Parameters:	Required prior to the test	During the t	est	
Ambient Temperature	15 to 35 °C	26.0 °C		
Relative Humidity	30 to 60 %	25.6 %		
	Power interface mode	1		
EQUIPMENT mode	EUT configurations mode	1		
	Operation mode	6		
Classification of EQUIPMENT Classification				
Supplementary information:				

Test equipment used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P1088	4-quadrant amplifier (L1)	SPIBE	PAS 20000	A339201/0 0904	cnn		
P1288	power supply	SPIBE		A3758 02/0 1006	cnn		
P1286	4-quadrant amplifier (L2)	SPIBE	PAS 20000	A3758 01/1 1006	cnn		
P1287	4-quadrant amplifier (L3)	SPIBE	PAS 20000	A3758 01/2 1006	cnn		
P1090	control unit	SPIBE	SyCore 1k4		cnn		
P1091	analyzer reference system	SPIBE	ARS 16/3	A3392 07/1 0904	cal	Apr 03, 2019	Apr 2021
P1911	Data logger for pressure, humidity and temperature (Spibe)	testo AG	testo 176 P1	41000861 403+ 60244991	cal	Aug 22, 2017	Aug 2020

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance



Name:		Ratkovic				anufactu	rer:	ADLI	NK MLC	3-23 EUT 3		
Depar Compa		EM V-Lat SGS	bor		O C C	erial no: perating omment omment ate of tes	2:	AC 2	30V 50H2 2019	2		
Voltag Currer Power	e: nt:	rrent and co 230.60 Vrm 0.492 Arms 105.2 W 0.927		TH TH N 113	ow 1: D=0.02 D=31.68 3.5 VA		THV=0.0 THC=0.1				PWHD=(PWHD=1	
Test c	onditions:	Time windo No Ztest se	3-2:2014,	Grouping (>	2nd har	m.)=on	calc. of	THD, TH	IC, POH	C, PWHD		
			Tobs = entire			IC:avg=		imits=0.2	25 A			
		Entirem	easurement (0.200		0			Worst	2.5 min	Averag	ge	PF
На	Maximum	Window	EN61000-3-2 Class A	Margin in MaxWin	100 to 150%	150 to 200%	Ex- ceeded	100 to 150%	Ex- ceeded	Value	Ex- ceeded	A A S I S L
DC	-0.0014 A				0	0	0	n.e.	n.e.	-0.0014 A	0	X
1 2	0.4689 A 0.0033 A	1 1	1.0800 A	-99.7 %	0	0	0	n.e. n.e.	n.e. n.e.	0.4689 A 0.0033 A	0	X X
3	0.1442 A		2.3000 A	-93.7 %	0	0	0	n.e.	n.e.	0.1442 A	0	X
4	0.0010 A		0.4300 A	-99.8 %	0	0	0	n.e.	n.e.	0.0010 A	0	X
5 6	0.0226 A 0.0009 A	1	1.1400 A 0.3000 A	-98.0 % -99.7 %	0	0	0	n.e. n.e.	n.e. n.e.	0.0226 A 0.0009 A	0	X X
7	0.0144 A	1 1	0.7700 A	-98.1 %	0	0	0	n.e.	n.e.	0.0144 A	0	x
8	0.0006 A		0.2300 A	-99.7 %	0	0	0	n.e.	n.e.	0.0006 A	0	X
9	0.0131 A	1 1	0.4000 A	-96.7 %	0	0	0	n.e.	n.e.	0.0131 A	0	X
10 11	0.0004 A 0.0075 A	1	0.1840 A 0.3300 A	-99.8 % -97.7 %	0 0	0 0	0 0	n.e. n.e.	n.e. n.e.	0.0004 A 0.0075 A	0 0	X X
12	0.0005 A	1 1	0.1533 A	-99.7 %	0	0	0	n.e.	n.e.	0.0005 A	0	X
13	0.0067 A	1	0.2100 A	-96.8 %	0	0	0	n.e.	n.e.	0.0067 A	0	Х
14 15	0.0004 A 0.0051 A		0.1314 A 0.1500 A	-99.7 % -96.6 %	0 0	0 0	0 0	n.e. n.e.	n.e. n.e.	0.0004 A 0.0051 A	0 0	X X
16	0.0001 A		0.1150 A	-99.5 %	0	0	0	n.e.	n.e.	0.0001 A	0	x
17	0.0058 A		0.1324 A	-95.6 %	0	0	0	n.e.	n.e.	0.0058 A	0	x
18	0.0005 A		0.1022 A	-99.6 %	0	0	0	n.e.	n.e.	0.0005 A	0	X
19 20	0.0046 A 0.0005 A	1	0.1184 A 0.0920 A	-96.1 % -99.5 %	0 0	0	0	n.e. n.e.	n.e. n.e.	0.0046 A 0.0005 A	0	X X
21	0.0030 A	1	0.1071 A	-97.2 %	0	0	0	n.e.	n.e.	0.0000 A	0	X
22	0.0006 A	1	0.0836 A	-99.3 %	0	0	0	n.e.	n.e.	0.0006 A	0	X
23 24	0.0055 A 0.0007 A	1 1	0.0978 A 0.0767 A	-94.4 % -99.1 %	0	0	0	n.e.	n.e. n.e.	0.0055 A 0.0007 A	0	X X
24 25	0.0007 A	1	0.0767 A 0.0900 A	-99.1 % -96.5 %	0	0	0	n.e. n.e.	n.e.	0.000/ A 0.0031 A	0	x
26	0.0008 A	. 1	0.0708 A	-98.8 %	0	0	0	n.e.	n.e.	0.0008 A	0	X
27	0.0079 A	1	0.0833 A	-90.5 %	0	0	0	n.e.	n.e.	0.0079 A	0	X X
28 29	0.0008 A 0.0023 A	1	0.0657 A 0.0776 A	-98.7 % -97.1 %	0 0	0	0	n.e. n.e.	n.e. n.e.	0.0008 A 0.0023 A	0	X X
30	0.0008 A	. 1	0.0613 A	-98.6 %	0	0	0	n.e.	n.e.	0.0008 A	0	X
31	0.0026 A	1	0.0726 A	-96.4 %	0	0	0	n.e.	n.e.	0.0026 A	0	X
32 33	0.0009 A 0.0043 A	1	0.0575 A 0.0682 A	-98.5 % -93.6 %	0 0	0	0	n.e. n.e.	n.e. n.e.	0.0009 A 0.0043 A	0	X X
34	0.0009 A	1 1	0.0541 A	-98.3 %	0	0	0	n.e.	n.e.	0.0040 A	0	x
35	0.0038 A	. 1	0.0643 A	-94.1 %	0	0	0	n.e.	n.e.	0.0038 A	0	x
36	0.0009 A	1	0.0511 A	-98.3 %	0	0	0	n.e.	n.e.	0.0009 A	0	X
37 38	0.0047 A 0.0008 A	1	0.0608 A 0.0484 A	-92.3 % -98.3 %	0	0	0	n.e. n.e.	n.e. n.e.	0.0047 A 0.0008 A	0	X X
39	0.0017 A	1	0.0577 A	-97.1 %	0	0	0	n.e.	n.e.	0.0000 A	0	x
	0.0006 A	. 1	0.0460 A	-98.7 %	0	0	0	n.e.	n.e.	0.0006 A	0	X
40												

1.12 Test Conditions and Results – Voltage changes, voltage fluctuations and flicker

IEC 61000-3-3: 2013	2013 Test Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection								
			Р						
Laboratory Parameters: Required prior to the test During the test									
Ambient Temperature	15 to 35 °C	26.0 °C							
Relative Humidity	30 to 60 %	25.6 %							
	Power interface mode:	: 1							
EQUIPMENT mode	EUT configurations mode:	1	1						
	Operation mode:	6							
Control Method of EQU	PMENT (see below)	1							
1 - without additional co	nditions								
	n nore frequently than twice per day, and also v tens of seconds), or manual restart, after a		the delay						
than twice per day, and	e, or switched on automatically, or is intended also has either a delayed restart (the delay b art, after a power supply interruption.								

Supplementary information:

Test Equipment Used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P1088	4-quadrant amplifier (L1)	SPIBE	PAS 20000	A339201/0 0904	cnn		
P1288	power supply	SPIBE		A3758 02/0 1006	cnn		
P1286	4-quadrant amplifier (L2)	SPIBE	PAS 20000	A3758 01/1 1006	cnn		
P1287	4-quadrant amplifier (L3)	SPIBE	PAS 20000	A3758 01/2 1006	cnn		
P1090	control unit	SPIBE	SyCore 1k4		cnn		
P1091	analyzer reference system	SPIBE	ARS 16/3	A3392 07/1 0904	cal	Apr 03, 2019	Apr 2021
P1911	Data logger for pressure, humidity and temperature (Spibe)	testo AG	testo 176 P1	41000861 403+ 60244991	cal	Aug 22, 2017	Aug 2020



	Tabul	ated R	esults f	for Volt	age Fluc	tuation	s and	Flic	ker		
	Name: Department: Company:		kovic V-Labor S		Manufacturer: Serial no: Operating mod Comment1: Comment2: Date of test:		NK MLC8-1 80V 50Hz 2019	23 EUT	3		
	Test conditio		00-4-15:2011	/ Obs 1 x 10 1500) Ohm/ F	z / Phase L1 min / Ztest (0.400 Rn+jXn (0.1600+j R: Test PASS!						
	Time	Pmax	Pst	Sliding Plt	Tmax[s]	dmax[%]	dc [%]	PASS	EAU		
	16:08:35	0.010	0.0720		0.000	+0.000	uc [%]	глоо Х	FAIL		
	Limits:	0.010	1.000	0.650	0.500	4.000	3.300	^			
					0.500	4.000	3.300				
	Plt: 0.03144	9 (calculated	dover 12 peri	ods)				Х			
	Evaluated:	PST, PLT, SI	iding PLT, de	c, dmax, Tma	ĸ						
				FLICKER: S	ource test PASS	!					
	Time	Pmax	Pst	Sliding Plt	Tmax[s]	dmax[%]	dc [%]	PASS	FAIL		
	16:08:35	0.000	0.0090		0.000	+0.000		х			
	Plt: 0.00393	1 (calculated	dover 12 peri	ods)							
	Evaluated:	PST <= 0.4	dmax < 20 °	% dmax1				1			
		Tested with SP	S EMC 4.1.3/ PA S2000	Dby Spitzenberger & Spie	s GmbH & Co. KG, Schmidstr.32	-34, 94234 Viechtach, Gerr	many, 15.05.2019				
										-	
L											

1.13 Test Conditions and Results – Electrostatic discharge IMMUNITY

IEC 61000-4-2: 2008	٦	TEST:	Electrostat	tic discharge IMMUN	ΙΙΤΥ	Verdict	
						Р	
Laboratory Paramete	rs:	Required prior to the test During			During the test		
Ambient Temperature	•		15 to	35 °C	27.5 °C		
Relative Humidity			30 to	60 %	36.7 %		
Atmospheric Pressur	e			0 mbar) to 060 mbar)	101 kPa (1012 mba	ar)	
EQUIPMENT mode	F	Powe	r interface m	ode	4, 1		
	E	EUT c	onfiguration	ns mode	1		
	C	Opera	ation mode	5, 6			
	<u>.</u>		IMMUNI	TY TEST LEVELS			
Discharge type	Discha	arge l	Level (kV)	Number of disch	narges per location (each p	olarity)	
	Positi	ve	Negative				
Air – Direct	2, 4, 8,	15	2, 4, 8, 15		10		
Contact – Direct	8		8		10		
Contact – Indirect	Contact – Indirect 8 8 10						
Discharge location	ļ	All ex	ternal location	oto documentation ons accessible by Vertical coupling p	hand, Horizontal plate (HC	P)	
Supplementary informa	tion: EU	T pow	rered at one o	of the Nominal input	oltages and frequencies		
Note: In battery mode:	power ca	able at	ttached, but s	supply voltage turne	d off		

Test Equipment Used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0726	vertical coupling plane	Keytek	VCP-1	9209343	cnn		
P0983	ESD generator, basic unit	EMC Partner	ESD3000	243/70	cal	Apr 02, 2019	Apr 2021
P0984	ESD generator, discharge	EMC Partner	ESD3000DM1	068	cal	Apr 02, 2019	Apr 2021
	module					-	-
P0977	test chamber 6	Siemens			chk	Feb 22, 2019	Feb 2020
P1917	Data logger for humidity	testo AG	testo 175 H1	40342579	cal	Aug 19, 2017	Aug 2020
	and temperature (MZ6)					•	-

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance

Photo of test setup for IMMUNITY to Electrostatic Discharges



	Nominal Voltage (V)	:	24 V	DC
	Nominal Frequency (Hz)):	-	
Direct	discharges: Air and Co	ontact		
point accessible for INTENDED USE (if not shown on attached photos)	Air discharge voltage (kV)	Polar	ity	Result
See photos of discharge test locations	2	+/-		1
	4	+/-		1
	8	+/-		1
	15	+/-		1
point accessible for INTENDED USE (if not shown on attached photos)	Contact discharge voltage (kV)	Polar	ity	Result
See photos of discharge test locations	2	+/-		1
	4	+/-		1
	8	+/-		1
	Indirect discharges			
point accessible for INTENDED USE (if not shown on attached photos)	Contact discharge voltage (kV)	Polar	ity	Result
НСР	8	+/-		1
VCP - Front	8	+/-		1
VCP - Left	8	+/-		1
VCP - Right	8	+/-		1
VCP - Rear	8	+/-		1

detail observations during testing (add more numbers where needed).

	Nominal Voltage (V)	:	230 VAC
	Nominal Frequency (Hz)):	50 Hz
Direc	t discharges: Air and Co	ontact	
point accessible for INTENDED USE (if not shown on attached photos)	Air discharge voltage (kV)	Polarity	Result
See photos of discharge test locations	2	+/-	1
	4	+/-	1
	8	+/-	1
	15	+/-	1
point accessible for INTENDED USE (if not shown on attached photos)	Contact discharge voltage (kV)	Polarity	Result
See photos of discharge test locations	2	+/-	1
	4	+/-	1
	8	+/-	1
	Indirect discharges		
point accessible for INTENDED USE (if not shown on attached photos)	Contact discharge voltage (kV)	Polarity	Result
НСР	8	+/-	1
VCP - Front	8	+/-	1
VCP - Left	8	+/-	1
VCP - Right	8	+/-	1
	8	+/-	1

Note: When further description/comments are need, use result numbers beyond description two (2) to detail observations during testing (add more numbers where needed).



Test Conditions and Results - Radiated, radio-frequency, electromagnetic field IMMUNITY 1.14

	0-4-3: 2006 7 +A2: 2010	TEST: R		, radio-frequency, electrom	agnetic field	Verdict		
		•				Р		
Laborato	ory Parameters		Requi	red prior to the test	During th	ne test		
Ambient	Temperature			15 to 35 °C	25.3	°C		
Relative	Humidity			30 to 60 %	35.3	%		
EQUIPMI	ENT mode	Pow	ver inter	ace mode	4, 1			
		EUT	Γ configι	irations mode	1			
		Оре	eration m	ode	5, 6	5		
				Test specifications				
	Frequency ba	ndwidth		80 MH	z to 2700 MHz			
	Modulati	on		⊠ 80% AM at 1 kHz*	☐ Other			
q	Profession Envir	al Health onment	care	□ 3V/m				
Level Applied (V/m)	Home Healthcare Environment			⊠ 10V/m				
, level , V)	Special E	invironme	ent	☐ Other				
	Ot	hers						
	Frequency	step		⊠ 1%	Other _			
Suppleme	entary information	n:						
			•	ltages and frequencies. noted in results table.				
Actual IM	MUNITY TEST LEV	EL noted i	n results	table.				
Note * - T	esting may be p	performed	at other	modulation frequencies iden	tified by the RISK MA	NAGEMENT		

PROCESS.

Test Equipment Used ID Description Manufacturer Model Serial No. Status Cal. date Cal. due Equipment for 80 MHz - 1000 MHz P0261 R&S NRVS 864297/029 cal Apr 02, 2019 Apr 2021 power meter NRV-Z51 P0287 R&S 829004/017 Apr 02, 2019 Apr 2020 power sensor cal P0338 test chamber 3 Siemens chk Feb 22, 2019 Feb 2020 P0769 attenuator 20dB Narda 768-20 8004 chk Oct 15, 2018 Oct 2019 04D00215SN EM radiation meter, P0906 Dare RadiSense IV cal Jun 12, 2017 Jun 2019 readout unit (MZ3) O28 EM radiation meter, 28 Jun 2019 P0907 Dare RadiSense IV Jun 12, 2017 cal probe (MZ3) P1328 AR 500 W/1000A 0326009 amplifier cnn MECA P1621 terminator (MZ3) 50 Ohm/ 15 W chk Sep 05, 2018 Sep 2019 Electronics C6338-20 (50 dB/ P2399 116624 **Dual Directional Coupler** Werlatone chk Jul 25, 2018 Jul 2019 2500W) P0998 R&S 100539 Mar 23, 2017 Mar 2020 signal generator SML 03 cal 3140 1003 P0032 antenna K (MZ3) Emco cnn Equipment for 1 GHz - 2.7 GHz P0338 test chamber 3 Siemens chk Feb 22, 2019 Feb 2020 P0568 R&S **SMR 20** 100370 cal Apr 04, 2019 Apr 2020 signal generator AS0104-400/200amplifier, Dual Band P1196 Milmega 1012671 cnn Solid State 1-3b-22 P0525 RF coupler AR DC 7144 28855 chk Nov 19, 2018 Nov 2019 P0288 NRV-Z51 829004/013 R&S Apr 02, 2019 Apr 2020 power sensor cal P0264 R&S NRVS 836020/19 Apr 04, 2018 power meter cal Apr 2020 P0029 antenna Emco 3105 2025 chk Oct 17, 2018 Oct 2020 P0190 EM radiation meter W&G EMR-200 BN 2244/21 cal Oct 12, 2017 Oct 2019 P1183 EM radiation probe W&G Oct 12, 2017 Oct 2019 Type 9.2 AG-0006 cal

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance





EUT orientation	IMMUNITY TEST LEVEL (V/m)	Antenna polarization (V/H)	Dwell Time (second)	Result
Front		н	1	1
		V	1	1
Back		н	1	1
		V	1	1
Left		н	1	1
		V	1	1
Right		н	1	1
		V	1	1
Тор		н	-	Х
		V	-	Х
Bottom		н	-	Х
		V	-	Х
X - Not performed n 1 – Compliant - No c	or required. observed response fron he response should deta Tabulated Result	il observations during te s for RF Electromagne	etic Field	
-	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna	etic Field ode 6 Dwell Time	Result
X - Not performed n 1 – Compliant - No c Note: Description of t	or required. observed response from he response should deta Tabulated Result 80 MHz to 270	il observations during te s for RF Electromagne 00 MHz – operation mo	etic Field ode 6	Result
X - Not performed n 1 – Compliant - No c Note: Description of t	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna	etic Field ode 6 Dwell Time	Result 1
X - Not performed n 1 – Compliant - No c Note: Description of t EUT orientation	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H)	etic Field ode 6 Dwell Time (second)	
X - Not performed n 1 - Compliant - No construction Note: Description of t EUT orientation	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H	etic Field ode 6 Dwell Time (second) 1	1
X - Not performed n 1 - Compliant - No c Note: Description of t EUT orientation Front	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V	etic Field ode 6 Dwell Time (second) 1 1	1
X - Not performed n 1 - Compliant - No c Note: Description of t EUT orientation Front	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H	etic Field ode 6 Dwell Time (second) 1 1 1 1	1 1 1
X - Not performed n 1 - Compliant - No c Note: Description of t EUT orientation Front Back	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1	1 1 1 1
X - Not performed n 1 - Compliant - No c Note: Description of t EUT orientation Front Back	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V H V H	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1 1 1 1	1 1 1 1 1 1
X - Not performed n 1 - Compliant - No constraint Note: Description of the EUT orientation Front Back Left	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V H V H	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1 1 1 1 1 1 1	1 1 1 1 1 1 1
X - Not performed n 1 - Compliant - No constraint Note: Description of the EUT orientation Front Back Left	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V H V H V H	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	1 1 1 1 1 1 1 1 1
X - Not performed n 1 - Compliant - No of Note: Description of t EUT orientation Front Back Left Right	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V H V H V H V	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	1 1 1 1 1 1 1 1 1 1
X - Not performed n 1 - Compliant - No of Note: Description of t EUT orientation Front Back Left Right	or required. observed response from he response should deta Tabulated Result 80 MHz to 270 IMMUNITY TEST LEVEL	il observations during te s for RF Electromagne 00 MHz – operation mo Antenna polarization (V/H) H V H V H V H V H V H	etic Field ode 6 Dwell Time (second) 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	1 1 1 1 1 1 1 1 1 1 X

Note: Description of the response should detail observations during testing.

1.15 Test Conditions and Results – Proximity fields from RF wireless communications EQUIPMENT

IEC 61000-4-3: 2006 2007 +A2: 2010		T: Proximity fields from RF w PMENT	virele	ss communicati	ions	Verdict
						Р
Laboratory Paramet	ers:	Required prior to the tes	t	Durin	ig the	test
Ambient Temperatu	re	15 to 35 °C		2	5.3 °C	
Relative Humidity		30 to 60 %		3	5.3 %	
EQUIPMENT mode		Power interface mode			4, 1	
		EUT configurations mode			1	
		Operation mode			5, 6	
		Test specifications				
Fre	quency Ran	ge and Level: RF wireless co	ommu	Inication EQUIPM	ENT	
Test Frequency (MHz)		Modulation		Minimum /UNITY Level (V/m)		JNITY Level blied (V/m)
385	**Pu	ulse Modulation: 18 Hz		27		27
450	⊠ *FM <u>+</u>	5 Hz deviation: 1 kHz sine		28		28
	□ ** P	Pulse Modulation: 18 Hz				
710	**Pul	se Modulation: 217 Hz		9		9
745 780						
810 870 930	**Pu	lse Modulation: 18 Hz		28		28
1720 1845 1970	**Pul	**Pulse Modulation: 217 Hz		28		28
2450	**Pul	se Modulation: 217 Hz		28		28
5240 5500 5785	**Pul	*Pulse Modulation: 217 Hz		9		9

Supplementary information:

Add more rows above if additional frequencies are required to be tested as identified in the RISK MANAGEMENT PROCESS.

EUT powered at one of the Nominal input voltages and frequencies. Dwell time minimum 1 s. Actual dwell time noted in results table.

Note * - As an alternative to FM modulation, 50 % pulse modulation at 18 Hz may be used because while it does not represent actual modulation, it would be worst case. CBTL shall indicate which modulation was used.

Note** - The carrier shall be modulated using a 50 % duty cycle square wave signal.

		Те	st Equipment Us	sed			
ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
Equipm	ent for 80 MHz – 1000 MH	z				•	
P0261	power meter	R&S	NRVS	864297/029	cal	Apr 02, 2019	Apr 2021
P0287	power sensor	R&S	NRV-Z51	829004/017	cal	Apr 02, 2019	Apr 2020
P0338	test chamber 3	Siemens			chk	Feb 22, 2019	Feb 2020
P0769	attenuator 20dB	Narda	768-20	8004	chk	Oct 15, 2018	Oct 2019
P0906	EM radiation meter, readout unit (MZ3)	Dare	RadiSense IV	04D00215SN O28	cal	Jun 12, 2017	Jun 2019
P0907	EM radiation meter, probe (MZ3)	Dare	RadiSense IV	28	cal	Jun 12, 2017	Jun 2019
P1328	amplifier	AR	500 W/1000A	0326009	cnn		
P1621	terminator (MZ3)	MECA Electronics	50 Ohm/ 15 W		chk	Sep 05, 2018	Sep 2019
P2399	Dual Directional Coupler	Werlatone	C6338-20 (50 dB/ 2500W)	116624	chk	Jul 25, 2018	Jul 2019
P0998	signal generator	R&S	SML 03	100539	cal	Mar 23, 2017	Mar 2020
P0032	antenna K (MZ3)	Emco	3140	1003	cnn		
Equipm	ent for 1 GHz – 2.7 GHz						
P0338	test chamber 3	Siemens			chk	Feb 22, 2019	Feb 2020
P0568	signal generator	R&S	SMR 20	100370	cal	Apr 04, 2019	Apr 2020
P1196	amplifier, Dual Band Solid State	Milmega	AS0104-400/200- 1-3b-22	1012671	cnn		
P0525	RF coupler	AR	DC 7144	28855	chk	Nov 19, 2018	Nov 2019
P0288	power sensor	R&S	NRV-Z51	829004/013	cal	Apr 02, 2019	Apr 2020
P0264	power meter	R&S	NRVS	836020/19	cal	Apr 04, 2018	Apr 2020
P0029	antenna	Emco	3105	2025	chk	Oct 17, 2018	Oct 2020
P0190	EM radiation meter	W&G	EMR-200	BN 2244/21	cal	Oct 12, 2017	Oct 2019
P1183	EM radiation probe	W&G	Type 9.2	AG-0006	cal	Oct 12, 2017	Oct 2019
Equipm	ent for 5 GHz – 6 GHz						
P0338	test chamber 3	Siemens			chk	Feb 22, 2019	Feb 2020
P0568	signal generator	R&S	SMR 20	100370	cal	Apr 04, 2019	Apr 2020
P1594	amplifier 1-18 GHz	Bonn	TWAL 0118- 30/20D	12880	cnn		
P0288	power sensor	R&S	NRV-Z51	829004/013	cal	Apr 02, 2019	Apr 2020
P0264	power meter	R&S	NRVS	836020/19	cal	Apr 04, 2018	Apr 2020
P0029	antenna	Emco	3105	2025	chk	Oct 17, 2018	Oct 2020
P0190	EM radiation meter	W&G	EMR-200	BN 2244/21	cal	Oct 12, 2017	Oct 2019
P1183	EM radiation probe	W&G	Туре 9.2	AG-0006	cal	Oct 12, 2017	Oct 2019

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance





Front 385 H 1 1 450 H 1 1 710 H 1 1 745 1 1 1 780 1 1 1 810 H 1 1 1 870 930 1 1 1 930 H 1 1 1 1845 H 1 1 1 5240 H 1 1 1 710 V 1 1 1 780 1 1 1 1 930 1 1 1 1 1720 V 1 1 1 17	UT Orientation	Test frequency (MHz)	Antenna polarization (V/H)	Dwell Time (second)	Result
710 H 1 745 1 1 780 1 1 810 H 1 1 870 930 1 1 930 1 1 1 1720 H 1 1 1720 H 1 1 1845 1 1 1 1970 H 1 1 2450 H 1 1 5500 Front 385 V 1 1 745 1 1 1 1 745 1 1 1 1 745 1 1 1 1 780 V 1	Front	385	Н	1	1
745 780 1 810 H 1 870 1 930 1 1720 H 1 1720 H 1 1720 H 1 1845 1 1 1970 1 1 2450 H 1 1 5500 1 1 1 5500 1 1 1 710 V 1 1 745 1 1 1 780 V 1 1 1970 V 1 1 1970 V 1 1 1970 V 1 1 1970<		450	Н	1	1
780 1 810 H 1 870 1 1 870 1 1 870 H 1 1 930 H 1 1 1720 H 1 1 1845 H 1 1 1970 H 1 1 2450 H 1 1 5240 H 1 1 5500 Front 385 V 1 1 5500 V 1 1 1 765 V 1 1 1 745 V 1 1 1 780 V 1 1 1 810 V 1 1 1 870 V 1 1 1 930 V 1 1 1 1720 V 1 1 1 <		710	Н	1	
810 H 1 1 870 930 1 1 930 1720 H 1 1 1720 H 1 1 1 1970 1 1 1 1 2450 H 1 1 1 5240 H 1 1 1 5500 Front 385 V 1 1 700 V 1 1 1 710 V 1 1 1 745 1 1 1 1 780 V 1 1 1 810 V 1 1 1 930 V 1 1 1 1970 V 1					1
870 930 1 1720 H 1 1720 H 1 1845 1 1970 1 2450 H 1 5240 H 1 5500 1 1 5785 1 1 Front 385 V 1 450 V 1 1 710 V 1 1 780 1 1 780 1 1 810 V 1 1 930 1 1 1 1970 1 1 1 810 V 1 1 1970 1 1 1 2450 V 1 1 5500 1 1 1 1970 1 1 1 2450 V 1 1 5785 1		780			
930 H 1 1720 H 1 1845 1 1 1970 H 1 1 2450 H 1 1 5240 H 1 1 5500 Front 385 V 1 1 450 V 1 1 1 710 V 1 1 1 710 V 1 1 1 780 1 1 1 1 780 V 1 1 1 1720 V 1 1 1 930 V 1 1 1 1970 V 1 1 1 5500 V 1 1			Н	1	
1720 H 1 1 1845 1970 1 1 2450 H 1 1 5240 H 1 1 5500 1 1 1 5500 1 1 1 5500 1 1 1 5500 1 1 1 5785 V 1 1 780 V 1 1 780 V 1 1 810 V 1 1 930 V 1 1 1970 V 1 1 1970 V 1 1 1970 V 1 1 2450 V 1 1 5240 V 1 1 5785 1 1 1 5785 H 1 1 745 H 1 1 <td></td> <td></td> <td></td> <td></td> <td>1</td>					1
1845 1970 1 1 2450 H 1 1 5240 H 1 1 5500 H 1 1 5500 Front 385 V 1 1 450 V 1 1 1 710 V 1 1 1 745 1 1 1 1 780 V 1 1 1 810 V 1 1 1 930 V 1 1 1 930 V 1 1 1 930 V 1 1 1 1845 1 1 1 1 930 V 1 1 1 1845 1 1 1 1 1970 V 1 1 1 5240 V 1 1 1					
1970 1 1 2450 H 1 1 5240 H 1 1 5500 5785 1 1 Front 385 V 1 1 450 V 1 1 1 710 V 1 1 1 745 1 1 1 1 780 V 1 1 1 810 V 1 1 1 930 V 1 1 1 930 V 1 1 1 1970 V 1 1 1 5240 V 1 1 1 5550 Fres 1 1 1 5785			Н	1	
2450 H 1 1 5240 H 1 1 5500 1 1 1 5785 V 1 1 Front 385 V 1 1 450 V 1 1 1 710 V 1 1 1 745 1 1 1 1 780 V 1 1 1 810 V 1 1 1 930 V 1 1 1 1970 V 1 1 1 5240 V 1 1 1 5785 H 1 1 1					1
5240 5500 5785 H 1 1 Front 385 V 1 1 450 V 1 1 710 V 1 1 710 V 1 1 745 1 1 1 780 1 1 1 810 V 1 1 870 1 1 1 930 1 1 1 1720 V 1 1 930 1 1 1 1845 1 1 1 930 1 1 1 930 1 1 1 1970 V 1 1 5500 V 1 1 5785 1 1 1 745 1 1 1 780 H 1 1 1 810 H <td></td> <td></td> <td></td> <td>4</td> <td>4</td>				4	4
5500 5785 1 1 Front 385 V 1 1 450 V 1 1 450 V 1 1 710 V 1 1 710 V 1 1 745 1 1 780 V 1 1 810 V 1 1 810 V 1 1 930 V 1 1 1720 V 1 1 930 V 1 1 1970 V 1 1 5500 V 1 1 5500 V 1 1 5785 H 1 1 710 H 1 1 745 H 1 1 780 H 1 1					
5785 1 1 Front 385 V 1 1 450 V 1 1 710 V 1 1 745 V 1 1 780 V 1 1 810 V 1 1 870 V 1 1 930 V 1 1 1720 V 1 1 930 V 1 1 1970 V 1 1 5500 V 1 1 5500 V 1 1 5500 V 1 1 5785 H 1 1 745 H 1 1 745 H 1 1 780 H 1 1			H	1	1
Front 385 V 1 1 450 V 1 1 710 V 1 1 710 V 1 1 745 1 1 1 780 V 1 1 810 V 1 1 870 V 1 1 930 V 1 1 1720 V 1 1 930 V 1 1 1970 V 1 1 1970 V 1 1 2450 V 1 1 5500 V 1 1 5785 1 1 1 710 H 1 1 745 1 1 1 780 1 1 1					•
710 V 1 1 745 1 1 780 1 1 780 V 1 1 810 V 1 1 870 V 1 1 930 V 1 1 930 V 1 1 1720 V 1 1 1845 1 1 1 1970 V 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5500 - 1 1 5785 - 1 1 8ack 385 H 1 1 710 H 1 1 1 780 - - 1 1 810 H 1 1 1	Front		V	1	1
710 V 1 1 745 1 1 780 1 1 810 V 1 1 870 1 1 1 930 V 1 1 930 V 1 1 1720 V 1 1 1845 1 1 1 1970 V 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5500 1 1 1 5785 H 1 1 8ack 385 H 1 1 710 H 1 1 1 780 1 1 1 1 810 H 1 1 1		450	v	1	
745 1 780 1 810 V 1 870 1 1 930 1 1 930 1 1 930 1 1 1720 V 1 1 930 1 1 1 1930 V 1 1 1930 V 1 1 1845 1 1 1 1970 V 1 1 2450 V 1 1 5500 V 1 1 5500 V 1 1 5785 1 1 1 8ack 385 H 1 1 710 H 1 1 1 780 1 1 1 1 810 H 1 1 1		710		1	
810 V 1 1 870 1 1 930 V 1 1 930 V 1 1 1720 V 1 1 1845 1 1 1 1970 V 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5500 V 1 1 5785 H 1 1 Back 385 H 1 1 710 H 1 1 1 745 1 1 1 1 780 H 1 1 1			-	-	1
870 1 930 V 1 1720 V 1 1845 1 1 1970 V 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5785 1 1 1 Back 385 H 1 1 710 H 1 1 1 745 1 1 1 1 780 H 1 1 1		780			
930 V 1 1720 V 1 1845 1 1 1970 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5785 1 1 1 Back 385 H 1 1 710 H 1 1 1 780 H 1 1 1 810 H 1 1 1		810	v	1	
1720 V 1 1 1845 1970 1 1 2450 V 1 1 5240 V 1 1 5240 V 1 1 5240 V 1 1 5500 V 1 1 5785 H 1 1 Back 385 H 1 1 710 H 1 1 1 745 H 1 1 1 780 H 1 1 1					1
1845 1970 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5785 H 1 1 Back 385 H 1 1 710 H 1 1 710 H 1 1 745 H 1 1 780 H 1 1		930			
1970 1 1 2450 V 1 1 5240 V 1 1 5500 V 1 1 5785 H 1 1 Back 385 H 1 1 710 H 1 1 710 H 1 1 780 H 1 1 810 H 1 1			v	1	
2450 V 1 1 5240 V 1 1 5500 V 1 1 5785 H 1 1 Back 385 H 1 1 450 H 1 1 1 710 H 1 1 1 745 1 1 1 1 780 H 1 1 1					1
5240 V 1 1 5500 - - 1 5785 H 1 1 Back 385 H 1 1 450 H 1 1 710 H 1 1 745 - 1 1 780 H 1 1					
5500 5785 1 1 Back 385 H 1 1 450 H 1 1 710 H 1 1 745 1 1 1 780 H 1 1				1	1
5785 Image: Sector of the sector			v	1	
Back 385 H 1 1 450 H 1 1 710 H 1 1 745 1 1 1 780 H 1 1					1
450 H 1 1 710 H 1 1 745 1 1 1 780 H 1 1					
710 H 1 745 1 780 1 810 H 1	Back		Н	1	1
745 1 780 1 810 H 1		450	Н	1	1
780 H 1			Н	1	
810 H 1					1
870 1 1			н	1	
930					1
4700		1720	н	1	1

	OPER	elds From RF Wireless (ATION MODES 1 AND 2		
EUT Orientation	Test frequency (MHz)	Antenna polarization (V/H)	Dwell Time (second)	Result
	1845 1970			
	2450	Н	1	1
	5240 5500	н	1	1
	5785			
Back	385	V	1	1
	450	V	1	1
	710 745 780	V	1	1
	810 870 930	v	1	1
	1720 1845 1970	V	1	1
	2450	v	1	1
	5240 5500 5785	V	1	1
Left	385	н	1	1
	450	Н	1	1
	710 745 780	н	1	1
	810 870 930	Н	1	1
	1720 1845 1970	н	1	1
	2450	Н	1	1
	5240 5500 5785	н	1	1
Left	385	V	1	1
	450	V	1	1
	710 745 780	v	1	1

	IE	C 60601-1-2		
Tabulated Res	ults for Proximity Fie	elds From RF Wireless (RATION MODES 1 AND 2	Communications Ec	QUIPMENT
EUT Orientation	Test frequency (MHz)	Antenna polarization (V/H)	Dwell Time (second)	Result
	810 870 930	V	1	1
	1720 1845 1970	v	1	1
	2450	v	1	1
	5240 5500 5785	V	1	1
Right	385	Н	1	1
	450	Н	1	1
	710 745 780	Н	1	1
	810 870 930	н	1	1
	1720 1845 1970	Н	1	1
	2450	Н	1	1
	5240 5500 5785	Н	1	1
Right	385	V	1	1
	450	v	1	1
	710 745 780	V	1	1
	810 870 930	V	1	1
	1720 1845 1970	V	1	1
	2450	V	1	1
	5240 5500 5785	V	1	1
Тор	385	Н		Х

_	IE	C 60601-1-2		
Tabulated Res	sults for Proximity Fie	elds From RF Wireless (RATION MODES 1 AND 2	Communications E	QUIPMENT
EUT Orientation	Test frequency (MHz)	Antenna polarization (V/H)	Dwell Time (second)	Result
	450	н		X
	710	Н		
	745			х
	780			
	810	Н		
	870			X
	930			
	1720	н		
	1845			X
	1970			
	2450	Н		X
	5240	н		
	5500			Х
	5785			
Тор	385	V		X
	450	V		Х
	710	V		
	745			Х
	780			
	810	V		
	870			X
	930			
	1720	V		
	1845			Х
	1970			
	2450	V		X
	5240	V		
	5500			X
	5785			
Bottom	385	Н		Х
	450	Н		Х
	710	Н		
	745			Х
	780			
	810	Н		
	870			X
	930			
	1720	Н		
	1845			X
	1970			
	2450	н		Х

Bottom	5240 5500 5785 385	H V	X
Bottom	5785 385	V	Y
Bottom	385	V	Λ
Bottom		V	
		v	Х
	450	V	Х
	710	V	
	745		Х
	780		
	810	V	
	870		Х
	930		
	1720	V	
	1845		Х
	1970		
	2450	V	Х
	5240	V	
	5500		Х
	5785		
esults Descriptions:			
- Not performed nor r – Compliant - No obse		m EUT.	

1.16 Test Conditions and Results – Electrical fast transient/burst IMMUNITY

IEC 61000-4-4: 2012	TEST: Electrical fast tr	ansient/burst IM	MUNITY	Verdict	
				Р	
Laboratory Parameters:	Required prior to the test During th			test	
Ambient Temperature	10 to 40 °	С	27.0 °C		
Relative Humidity	10 to 90 9	%	30.4 %		
	Measurement Point				
Fully configured sample subject to the levels shown		Input a.c. Pow	er Ports		
below.	Input d.c. Power Ports Signal Input/Output Ports				
EQUIPMENT mode	Power interface mode 4, 1				
	EUT configurations mo	1			
	Operation mode			5, 6	
	Applied I	_evel			
Application Point	(kV)	Coupling Meth	od Repetition Fred	luency (kHz	
Input a.c. Power Ports	±2	Direct Injectio	n 100		
Input d.c. Power Ports	±2 Direct Injection		on 100		
Signal Input/Output Ports	±1 Capacitive Clamp 100				
Supplementary information: EUT powered at one of the Nor	ninal input voltages and free	equencies.			

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0339	test chamber 4	Siemens			chk	Feb 22, 2019	Feb 2020
P0595	burst generator	Schloeder	SFT 4000	704002	cal	Apr 02, 2019	Apr 2022
P0593	burst coupling clamp	Schloeder	SFT410	kz01	chk	Mar 27, 2018	Mar 2020
P1915	Data logger for humidity	testo AG	testo 175 H1	40342591	cal	Aug 19, 2017	Aug 2020
	and temperature (MZ4)						

cal = Calibration, car = Calibration restricted use, chk = Check, chr = Check restricted use, cpu = Check prior to use, calchk = Calibration and check, ind = for indication only, cnn = Calibration not necessary, man = Maintenance

Photo of test setup for Electric	cal Fast Transients OP Mode 6
Mains	SIP/SOP COM port RS 232
FIP/COD Eth care at	
SIP/SOP Ethernet	

Tabulated Results for Electrical Fast Transients - operation mode 6				
Point of application Results				
Mains	1			
SIP/SOP Ethernet	1			
SIP/SOP COM port RS 232 1				
Results Descriptions: X - Not performed nor required. 1 – Compliant - No observed response from EUT.				
Supplementary information:				
Note: Description of the response should detail observations during testing.				

Photo of test setup for Electrical Fast Transients - operation mode 5



Tabulated Results for Electrical Fast Transients - operation mode 5				
Point of application	Results			
Mains	1			
SIP/SOP Ethernet	1			
SIP/SOP COM port RS 232 1				
Results Descriptions: X - Not performed nor required. 1 – Compliant - No observed response from EUT.				
Supplementary information: Note: Description of the response should detail observations during testing.				

1.17 Test Conditions and Results – Surge IMMUNITY

IEC 61000-4-5: 2005	5 TEST: Surge IMMUNI	ГҮ			Verdict
					Р
Laboratory Parame	ters:	Required prior to the test		During the test	
Ambient Temperatu	ıre	10 to 40 °C		27.6 °C	
Relative Humidity		10 to 90 %		40.1 %	
	Fully configured sample subject to the Measurement Point			ment Point	
levels shown below.		Input AC	and	DC Power Ports	
EQUIPMENT mode		Power interface mode 1		1	
		EUT configurations mode 1		e 1	
		Operation mode		6	
		Applied Level			
Application Point	[kV]	Requir	ed Su	rge Waveform	
Input Power Ports	0.5 and 1.0 (Line to Line) 0.5, 1.0 and 2.0 (Line to Earth)	Combination Wave (1.2 µs x 50 µs Voltage, 8 µs x 20 µs Current) Combination Wave (1.2 µs x 50 µs Voltage, 8 µs x 20 µs Current)			
Signal input/output*	2.0 (Line to Earth)	Combination Wave (1.2 µs x 50 µs Voltage, 8 µs x 20 µs Current)			
	е sysтемs that do not ha at 2 kV line(s) to earth a	- ·		e in the primary pow	er circu
Supplementary infor EUT powered at one	mation: of the Nominal input voltag	ges and frequencies.			

Note* - Applicable to output lines intended to connect directly to outdoor cables

Test Equipment Used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0977	test chamber 6	Siemens			chk	Feb 22, 2019	Feb 2020
P1614	Ultra Compact Simulator (3-Phase Testsystem)	EMTest	UCS 500 N5	V1222112714	cal	Apr 03, 2019	Apr 2021
P2428	Coupling/decoupling network, 63 A (3-Phase Testsystem)	EMTest	CNI 503 A4	P1828221682	cal	Apr 03, 2019	Apr 2021
P1632	Electrical socket distributor (for Surge/Burst 63A)	Steidele- Stromverteiler GmbH	SVG 63/111-0-S	063292	cnn		
P1629	Oscilloscope, (used for Surge/Burst 63A)	LeCroy	WaveJet 354	LCRY0101J26657/22798	cal	Apr 02, 2019	Apr 2020
P1557	Notebook Labor EMV 03 (used for Surge/EFT 63A)	Lenovo	Think Pad T400	L3-ADN3C 08/11	cnn		
P1917	Data logger for humidity and temperature (MZ6)	testo AG	testo 175 H1	40342579	cal	Aug 19, 2017	Aug 2020



Mode of Application	Level	Polarity	Results
		Positive	1
e 1 to Line 2	0.5 kV	Negative	1
ferential mode)	1.0 kV	Positive	1
		Negative	1
		Positive	1
	0.5 kV	Negative	1
e 1 to Earth		Positive	1
mmon mode)	1.0 kV	Negative	1
		Positive	1
	2.0 kV	Negative	1
		Positive	X
	0.5 kV	Negative	X
Line 2 to Earth Common mode)	1.0 kV	Positive	X
		Negative	X
	2.0 kV	Positive	X
		Negative	X
	0.5 kV	Positive	X
		Negative	X
e 3 to Earth	1.0 kV	Positive	X
mmon mode)		Negative	X
	2.0 kV	Positive	X
		Negative	X
	0.5.11/	Positive	1
	0.5 kV	Negative	1
Neutral to Earth	4.0114	Positive	1
mmon mode)	1.0 kV	Negative	1
	0.011/	Positive	1
	2.0 kV	Negative	1

IEC 60601-1-2	

Tabulated Results for Surge – Signal Input/output Lines Directly Connected to Outdoor Lines			
Mode of Application	Level	Polarity	Results
Line 1 to Earth (Common mode)	2 kV	Positive	N/A
		Negative	N/A
Line 2 to Earth (Common mode)	2 kV	Positive	N/A
		Negative	N/A
Results Descriptions: X - Not performed nor required. 1 – Compliant - No observed response	from EUT.		
Supplementary information: Note: Description of the response should	detail observati	ons during testing.	
IEC 606	01-1-2		
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1.18 Test Conditions and Results – IMMUNITY to conducted disturbances, induced by radio-frequency fields

IEC 61000-4-6: 2013 TEST: IMMUNITY to conducted disturbances, induced by radio- frequency fields					
					Р
Labor	atory Parameter	s:	Required prior to the test	During the	test
Ambie	ent Temperature		10 to 40 °C	25.3 °C	
Relativ	ve Humidity		10 to 90 %	38.7 %	
			Power interface mode	4, 1	
EQUIPM	IENT mode		EUT configurations mode	1	
			Operation mode	5, 6	
Test S	pecifications:		Frequency range	Measurement	Point
Fully configured sample scanned over the following frequency range			150 kHz to 80 MHz	Input a.c. Power Ports Input d.c. Power Ports Signal Input/output Port PATIENT Connected Por	
	Home Healthca	re Environment	3 V RMS outside the ISM b amateur ra		ISM and
Level		l Healthcare nment	⊠ 3 V RMS outside the ISM band, 6 V RMS in the ISM band		
	Special En	vironment			
	Frequency	step	□ 1%	Other	
	Modulati	on	⊠ 80% AM at 1 kHz*	80% AM at 1 kHz*	
Supplementary information: EUT powered at one of the Nominal input voltages and frequencies. Dwell time minimum 1 s.					

Note * - Testing may be performed at other modulation frequencies identified by the RISK MANAGEMENT PROCESS.

Test Equipment Used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P0977	test chamber 6	Siemens			chk	Feb 22, 2019	Feb 2020
P1094	signal generator MZ6	R&S	SML 03	836927/030	cal	Mar 23, 2017	Mar 2020
P1387	amplifier	Instruments for Industry	M50	M637-0508	cnn		
P1194	RF coupler	Werlatone	C6021-10	19541	chk	Nov 19, 2018	Nov 2019
P0287	power sensor	R&S	NRV-Z51	829004/017	cal	Apr 02, 2019	Apr 2020
P0262	power meter	R&S	NRVS	864270/007	cal	Apr 04, 2018	Apr 2020
P0115	cdn	FCC	FCC-801-M3-16A	98103	cal	Apr 05, 2019	Apr 2021
P1117	cdn, 32A	EM-test	CDN-M1	0202-01	cal	Apr 08, 2019	Apr 2021
P0612	injection clamp	FCC	FCC-203I-EM	67	cal	Apr 10, 2018	Apr 2020
P0997	injection clamp	FCC	FCC-203I-EM	303	cal	Apr 01, 2019	Apr 2021
P0611	injection clamp	Luethi	EM 101	9435124	cal	Apr 01, 2019	Apr 2021
P0189	EM radiation meter	W&G	EMR20	C0076	cal	Jul 20, 2018	Jul 2020
P1028	EM radiation probe	W&G	Type 8.2	C-0076	cal	Jul 20, 2018	Jul 2020



Tabulated Results for Conducted Disturbances – operation mode 6						
Point of Application Results Dwell Time (second)						
Mains	1	1				
SIP/SOP 1 – Com port RS232	1	1				
SIP/SOP 2 - Ethernet 1 1						
Supplementary information: Results Descriptions: X - Not performed nor required.						

1 – Compliant - No observed response from EUT.

Note: Description of the response should detail observations during testing.

Note: Describe each **PORT** tested. Note: Delete rows not used



Tabulated Results for Conducted Disturbances - operation mode 5						
Point of Application Results Dwell Time (second)						
Mains 1 1						
SIP/SOP 1 – Com port RS232 1 1						
SIP/SOP 2 - Ethernet	1	1				
Supplementary information: Results Descriptions:						
X - Not performed nor required. 1 – Compliant - No observed response from EUT.						
Note: Description of the response should detail observations during testing.						

Note: Describe each **PORT** tested. Note: Delete rows not used

1.19 Test Conditions and Results – Power frequency magnetic field IMMUNITY

IEC 61000-4-8: 2009 TEST: Power frequency magnetic field IMMUNITY				
				Р
Laboratory Parameters:		Required prior to the test	During the tes	t
Ambient Temperature		10 to 40 °C	25.6 °C	
Relative Humidity		10 to 90 %	27.3 %	
EQUIPMENT mode		Power interface mode	4, 1	
		EUT configurations mode	1	
		Operation mode	5, 6	
Fully configured sample power line frequency (\$		Frequency	Application Point	
		50 Hz and 60 Hz	Enclosure	
IMMUNITY TEST LE	VEL	30 (A/m)		

Supplementary information:

Note 1: EUT powered at one of the Nominal input voltages and frequency of either 50 Hz or 60 Hz. During the test, the frequency of the field and line frequency of the ME EQUIPMENT were the same.

□ Test does not apply. Device under test does not contain magnetically sensitive components or circuitry.

Test EQUIPMENT Used

ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P2076	Power Supply	PCE Power Control GmbH & Co. KG	Chroma 61605, AC- /DC Source	616050001644	ind		
P1297	EM radiation meter	Chauvin Arnoux	C.A 42	100426AEK	cal	Jul 17, 2018	Jul 2019
P1238	antenna	QE13	Loop 2m x 3m		cnn		
P0081	antenna	QE13	Loop	L01	cnn		
P1298	EM radiation probe	Chauvin Arnoux	MF-400	100394AEK	cal	Jul 17, 2018	Jul 2019
P1911	Data logger for pressure, humidity and temperature (Spibe)	testo AG	testo 176 P1	41000861 403+ 60244991	cal	Aug 22, 2017	Aug 2020



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_	-/ 1		J

Tabulated Results for Power Frequency Magnetic Field - operation mode 6					
Point of application Results					
X-Axis 1					
Y-Axis	1				
Z-Axis	1				
Supplementary information: Results Descriptions:					

X - Not performed nor required. 1 – Compliant - No observed response from EUT.

Tabulated Results for Power Frequen	cy magnetie riela - operation mode o			
Point of application Results				
X-Axis	1			
Y-Axis 1				
Z-Axis	1			
upplementary information:				
esults Descriptions:				
K - Not performed nor required.				

1 – Compliant - No observed response from EUT.

1.20 Test Conditions and Results – Voltage dips, short interruptions and voltage variations IMMUNITY

IEC 61000-4-11: 2004 TEST: Voltage dips, short interruptions and voltage variations				
			Р	
Laboratory Parameters:	Required prior to the test	During the test	:	
Ambient Temperature	10 to 40 °C	26.0 °C		
Relative Humidity	10 to 90 %	25.6 %		
Fully configured subjected to the	e Measure	ment Point		
levels indicated below.	Input A.C. Power Ports			
EQUIPMENT mode	Power interface mode	2, 3	2, 3	
	EUT configurations mode	1	1	
	Operation mode	6	6	
	Applied Levels			
Voltage Dips (% UT)	Cycles	Sync Angle (deg	Sync Angle (degrees)	
0	0.5*	0; 45; 90; 135; 180; 315	0; 45; 90; 135; 180; 225; 270; 315	
0	1	0		
70	25 (50 Hz) 30 (60 Hz)	0		
Voltage Interruption % Uτ	Cycles	Sync Angle [deg	grees]	
0	250 (50 Hz),300 (60 Hz)	Any		

Supplementary information:

If the Rated voltage range <25 % of the lowest rated input voltage, one rated input voltage. Otherwise, minimum and maximum rated voltage. EUT powered at one of the Nominal input frequencies.

ME EQUIPMENT and ME SYSTEMS with power input voltage selection by transformer taps tested at only one tap setting.

Note* - Only applicable to ME EQUIPMENT with single phase a.c. mains

Supply Voltage Range	Difference of Max Voltage – Min Voltage	25 % of Lowest Rated input Voltage	Test at Min/Max Voltages required (Y/N)
100-240 VAC	140 VAC	25 VAC	Y

Test Equ	uipment Used
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ID	Description	Manufacturer	Model	Serial No.	Status	Cal. date	Cal. due
P1088	4-quadrant amplifier (L1)	SPIBE	PAS 20000	A339201/0 0904	cnn		
P1288	power supply	SPIBE		A3758 02/0 1006	cnn		
P1286	4-quadrant amplifier (L2)	SPIBE	PAS 20000	A3758 01/1 1006	cnn		
P1287	4-quadrant amplifier (L3)	SPIBE	PAS 20000	A3758 01/2 1006	cnn		
P1090	control unit	SPIBE	SyCore 1k4		cnn		
P1091	analyzer reference system	SPIBE	ARS 16/3	A3392 07/1 0904	cal	Apr 03, 2019	Apr 2021
P1911	Data logger for pressure, humidity and temperature (Spibe)	testo AG	testo 176 P1	41000861 403+ 60244991	cal	Aug 22, 2017	Aug 2020



Tabulated Results for Voltage Dips and Interruptions								
	100							
	60							
Point of application	Voltage Dips	Period (Cycles)	Results					
Mains	0	0.5	1					
Mains	0	1	1					
Mains	70	25/30 (50/60 Hz)	1					
Point of application	Voltage Interruptions	Period (Cycles)	Results					
Mains	0	250/300 (50/60 Hz)	1					

Supplementary information:

Results Descriptions:

X - Not performed nor required.

1 – Compliant - No observed response from EUT.

Name:	Ratkovic		Manufacturer:	ADLINK I	ALC8-23 EUT 3	Name	e	Ratkovic		Manufacturer:	ADLINK N	ICL8-23 EUT 3
Department:	EM V-Labor		Serial no:				irtment:	EM V-Labor		Serial no:		
Company:	SGS		Operating modes:	AC 100V	60Hz	Comp	pany:	SGS		Operating modes:	AC 100V 6	50Hz
			Comment1:							Comment1:		
			Comment2:							Comment2:		
			Date of test:	15.05.201	9					Date of test:	15.05.2019	9
Test conditions:	EN 61000-4-11 volta		interruptions and variations t	test		Test	conditions:	EN 61000-4-11 volta		t interruptions and variations f	est	
	Voltage / frequency:		0.0 V / 60.0 Hz					Voltage / frequency:		00.0 V / 60.0 Hz		
	Test phase:		ng le phase / L1-N					Test phase:		ng le phase / L1-N		
	Executed test:	_6	1000-4-11_0% 0.5per					Executed test:	_6	61000-4-11_0% 1per		
	Test description	2	(non above engle) / 10 E eres	ما ما ما ما م	_			Test description:		(non alterna analla) / 40 E ana	مر مر مر مر مر مر مر	
	Disturbances per ste	p. 3	(per phase angle) / 10.5 sec o	ueray betwee	n			Disturbances per ste	:р. 3	(per phase angle) / 10.5 sec	Jelay Detweel	1
					1	-				1		
Step Disturbar	108	Test level	Duration		Phase angle(s) (Ref. L1)	Step	Disturban	De .	Test level	Duration		Phase angle(s) (Ref. L1)
1 Voltage o	lip / shart interruption	0 %	0.5 periods		0° L1 (45° steps)	1	Voltage di	p / short interruption	0 %	1 period		0° L1 (45° steps)
							_					
Test results:						Toot	results:					
root roodito.												
 Normal performance 	rmance within limits spe	cified by man	ufacturer, requestor or purch	naser		• N	Iormal perfor	mance within limits spe	cified by mar	ufacturer, requestor or purch	aser	
			mance which ceases after the							rmance which ceases after th		
			its normal performance, witho		ntervention					its normal performance, with		ntervention
		ation of perfo	mance, the correction of which	ch					ation of perfo	rmance, the correction of whi	sh	
	rator intervention							ator intervention				
	on or degradation of per							n or degradation of per				
owing to dam	age to hardware or softw	vare, or loss (of data			0	wing to dama	ge to hardware or soft	ware, or loss	of data		
Comments:						Com	ments:					
Comments.						Com	ITERIIS.					
	Tented with SPS EMC 4.1	3/ PA S20000 by Spitter	berger & Spies Grithi & Co. K G, Schmidstr. 3234, 94234	4Viechtach, Germany, 1	1.052019			Tested with SPS ENC 4.1	.3/ PA S20000 by Spitze	berger & Spies GribH & Co. K G. Schmidst. 3234, 9423	Wiechtech, Gemeny, 15	052019
Name:	Ratkovic		Manufacturer:	ADLINK I	/LC8-23 EUT 3	Name		Ratkovic		Manufacturer:	ADLINK N	ILC8-23 EUT 3
Department:	EM V-Labor		Serial no:			Depa	irtment:	EM V-Labor		Serial no:		
			Serial no: Operating modes:				irtment:			Serial no: Operating modes:	ADLINK N	
Department:	EM V-Labor		Serial no: Operating modes: Comment1:			Depa	irtment:	EM V-Labor		Serial no: Operating modes: Comment1:		
Department:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V	60Hz	Depa	irtment:	EM V-Labor		Serial no: Operating modes:		50Hz
Department:	EM V-Labor		Serial no: Operating modes: Comment1:		60Hz	Depa	irtment:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V 6	50Hz
Department:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V	60Hz	Depa	irtment:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V 6	50Hz
Department:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V	60Hz	Depa	irtment:	EM V-Labor		Serial no: Operating modes: Comment1: Comment2:	AC 100V 6	50Hz
Department:	EMV-Labor SGS	ae dips, shor	Serial no: Operating modes: Comment1: Comment2: Date of test:	AC 100V	60Hz	Depa Comp	irtment:	EMV-Labor SGS	ge dips, shar	Serial no: Operating modes: Comment1: Comment2:	AC 100V 6	50Hz
Department: Company:	EM V-Labor SGS EN 61000-4-11 volta;		Serial no: Operating modes: Comment1: Comment2: Date of test:	AC 100V	60Hz	Depa Comp	artment: pany:	EM V-Labor SGS EN 61000-4-11 volta		Serial no: Operating modes: Comment1: Comment2: Date of test: t interruptions and variations 1	AC 100V 6	50Hz
Department: Company:	EM V-Labor SGS EN 61000-4-11 voltag Voltage / frequency:	10	Serial no: Operating modes: Comment1: Comment2: Date of test:	AC 100V	60Hz	Depa Comp	artment: pany:	EMV-Labor SGS	10	Serial no: Operating modes: Comment1: Comment2: Date of test:	AC 100V 6	50Hz
Department: Company:	EM V-Labor SGS EN 61000-4-11 volta;	10 Si	Serial no: Operating modes: Comment1: Comment2: Date of test: interruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N	AC 100V	60Hz	Depa Comp	artment: pany:	EM V-Labor SGS EN 61000-4-11 volta Voltage / frequency:	10 Si	Serial no: Operating modes: Comment1: Comment2: Date of test: t interruptions and variations t 0.0 V / 60.0 Hz	AC 100V 6	50Hz
Department: Company:	EM V-Labor SGS EN 61000-4-11 voltage / frequency: Voltage / frequency: Test phase:	10 Si	Serial no: Operating modes: Comment1: Comment2: Date of test:	AC 100V	60Hz	Depa Comp	artment: pany:	EM V-Labor SGS EN 61000-4-11 volta Voltage / freq uency: Test phase Executed test: Test description:	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: t interruptions and variations to 0.0 V / 60.0 Hz ng le phase / L1-N	AC 100V 6	50Hz
Department: Company:	EM V-Labor SGS EN 61000-4-11 voltag Voltage / freq uency: Test phase: Executed test:	10 Si _f	Serial no: Operating modes: Comment1: Comment2: Date of test: interruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N	AC 100V 15.05.201 test	60Hz 9	Depa Comp	artment: pany:	EM V-Labor SGS EN 61000-4-11 volta Voltage / freq uency: Test phase: Executed test:	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: t interruptions and variations to 0.0 V / 60.0 Hz ng le phase / L1-N	AC 100V 6 15.05.2019 est	30Hz 9
Department: Company:	EMV-Labor SGS EN 61000-4-11 voltag Voltage / frequency: Test phase Executed test: Test description	10 Si _f	Serial no: Operating modes: Comment1: Comment2: Date of test interruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_76%-25per	AC 100V 15.05.201 test	60Hz 9	Depa Comp	artment: pany:	EM V-Labor SGS EN 61000-4-11 volta Voltage / freq uency: Test phase Executed test: Test description:	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test tinter ruptions and variations 1 000 V / 6000 Hz mgle phase / L1-N 1000-4-11_0%-250per	AC 100V 6 15.05.2019 est	30Hz 9
Department: Company: Test conditions:	EM V-Labor SGS EN 61000-4-11 voltag Voltage / freq uency: Test phase Executed test: Test description Disturbances per ste	10 Si p: 3	Serial no: Operating modes: Comment1: Comment2: Date of test Linter ruptions and variations to 0.0 V / 60.0 Hz 0.0 V / 60.0 Hz 1000-4.11_70%-25per Incer phase angle) / 10.5 sec of	AC 100V 15.05.201 test	60Hz 9	Depa Com Test (rtment: pany: conditions:	EM V-Labor SGS EN 61000-4-11 volta Voltage / frequency. Test phase Executed test: Test description Disturbances per site	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test tinter ruptions and variations 1 000 V / 6000 Hz mgle phase / L1-N 1000-4-11_0%-250per	AC 100V 6 15.05.2019 est	90Hz 9
Department: Company: Test conditions: Step Disturbal	EM V-Labor SGS EN 61000-4-11 voltag Voltage / freq uency: Test phase: Executed test: Test description Disturbances per ste	10 Si p: 3 Test level	Serial no: Operating modes: Comment1: Comment2: Date of test Linker ruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_70%-25per (per phase angle) / 10.5 soc of Duration	AC 100V 15.05.201 test	60Hz 9 n Phase angle(s) (Ref. L1)	Depa Com Test	rtment: pany: conditions:	EMV-Labor SGS EN 61000-4-11 volta Voltage / freq.uency: Test phase: Executed test Test description Disturbances per ste 28	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: U0.0V / 60.0 Hz ngle phase / L1-N s1000-4-11_0%-250per (per phase angle) / 10.5 sec / Duration	AC 100V 6 15.05.2019 est	30Hz 9 Phase angle(s) (Ref. L1)
Department: Company: Test conditions: Step Disturbal	EM V-Labor SGS EN 61000-4-11 voltag Voltage / freq uency: Test phase Executed test: Test description Disturbances per ste	10 Si p: 3 Test level	Serial no: Operating modes: Comment1: Comment2: Date of test Linter ruptions and variations to 0.0 V / 60.0 Hz 0.0 V / 60.0 Hz 1000-4.11_70%-25per Incer phase angle) / 10.5 sec of	AC 100V 15.05.201 test	60Hz 9	Depa Com Test (rtment: pany: conditions:	EM V-Labor SGS EN 61000-4-11 volta Voltage / frequency. Test phase Executed test: Test description Disturbances per site	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: tinter ruptions and variations 1 0.00 // 60.0 Hz ngle phase /L1-N 1000-4-11_0%-250per (per phase angle) / 10.5 sec of	AC 100V 6 15.05.2019 est	90Hz 9
Department: Company: Test conditions: Step Disturbal	EM V-Labor SGS EN 61000-4-11 voltag Voltage / frequency: Test phase: Executed test: Test description Disturbances per ste	10 Si p: 3 Test level	Serial no: Operating modes: Comment1: Comment2: Date of test Linker ruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_70%-25per (per phase angle) / 10.5 soc of Duration	AC 100V 15.05.201 test	60Hz 9 n Phase angle(s) (Ref. L1)	Depa Comp Test of Step	rtment: pany: conditions: Disturbane Voltage di	EMV-Labor SGS EN 61000-4-11 volta Voltage / freq.uency: Test phase: Executed test Test description Disturbances per ste 28	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: U0.0V / 60.0 Hz ngle phase / L1-N s1000-4-11_0%-250per (per phase angle) / 10.5 sec / Duration	AC 100V 6 15.05.2019 est	30Hz 9 Phase angle(s) (Ref. L1)
Department: Company: Test conditions: Step Disturbal	EM V-Labor SGS EN 61000-4-11 voltag Voltage / frequency: Test phase: Executed test: Test description Disturbances per ste	10 Si p: 3 Test level	Serial no: Operating modes: Comment1: Comment2: Date of test Linker ruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_70%-25per (per phase angle) / 10.5 soc of Duration	AC 100V 15.05.201 test	60Hz 9 n Phase angle(s) (Ref. L1)	Depa Comp Test of Step	rtment: pany: conditions:	EMV-Labor SGS EN 61000-4-11 volta Voltage / freq.uency: Test phase: Executed test Test description Disturbances per ste 28	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: U0.0V / 60.0 Hz ngle phase / L1-N s1000-4-11_0%-250per (per phase angle) / 10.5 sec / Duration	AC 100V 6 15.05.2019 est	30Hz 9 Phase angle(s) (Ref. L1)
Department: Company: Test conditions: Step Disturbat 1 Voltage of Test results:	EN 41000-4-11 voltas SGS EN 61000-4-11 voltas Voltage / freq uency: Test phase: Executed test: Test description Disturbances per ste noe ip / short interruption	10 Si p: 3 Test level 70 %	Serial no: Operating modes: Comment1: Comment2: Comment2: Date of test U.OV / 60.0 Hz ngle phase / L1-N 10.04 - 11_70%-25per (per phase angle) / 10.5 sec of Duration 30 periods	AC 100V 15.05201 test	60Hz 9 n Phase angle(s) (Ref. L1)	Depa Comp Test of 1 Test of	rtment: pany: conditions: Disturban Voltage di results:	EM V-Labor SGS EN 61000-4-11 volta Voltage / frequency: Test phase: Executed test: Test description Disturbances per site Disturbances per site Disturbances per site	11(Si ep: 3 Test level 0 %	Serial no: Operating modes: Comment1: Date of test: tinter ruptions and variations 1 00.0V / 60.0 Hz ngle phase / L1-N 1000-411_0%-250per (per phase angle) / 10.5 sec of Duration 300 periods	AC 100V 6 15.052019 est	30Hz 9 Phase angle(s) (Ref. L1)
Department: Company: Test conditions: Step Disturbat 1 Voltage of Test results: • Normal perfor	EMV-Labor SGS EN 61000-4-11 voltag Voltage / frequency: Test phase: Executed test: Test description Disturbances per ste ip / short interruption	p: 3	Serial no: Operating modes: Comment1: Comment2: Date of test: Linter ruptions and variations to 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_70%-25per [per phase angle] / 10.5 sec of Duration 30 periods	AC 100V 15.05201 test delay betwee	60Hz 9 Phase angle(s) (Ref. L1) 0° L1 (45° steps)	Test (rtment: pany: conditions: Voltage di results: vormal perfor	EMV-Labor SGS EN 61000-4-11 volta Voltage / freq.verxy: Test phase: Decould test: Test description: Disturbances per ste p/short interruption mance within limits spe	11(Si ep: 3 Test level 0 %	Serial no: Operating modes: Comment1: Comment2: Date of test: Unterruptions and veriations to 0.0V / 60.0 Hz ngle phase / L1-N 31000-4-11_0%-250per (per phase angle) / 10.5 sec Duration 300 periods utfacturer, requestor or purch	AC 100V 6 15.052019 est delay betweer	00Hz Phase angle(s) (Ref. L1) 0° L1 (45° steps)
Department: Company: Test conditions: Step Disturbar 1 Voltage of Test results: • Normal perfor o Temporary/o	EM V-Labor SGS EN 61000-4-11 voltag Voltage / freq uency: Test phase: Executed test: Test description Disturbances per ste noe iip / short interruption	p: 3 Test level 70 %	Serial no: Operating modes: Comment1: Comment2: Date of test 0.0 V / 60.0 Hz ngle phase / L1-N 10.04-H1_70%-25per (per phase angle) / 10.5 sec of Duration 30 periods ufacturer, requestor or purch mance which cesses after th	AC 100V 15.05.201 lest delay betwee maser e distur banc	60Hz 9 Phase angle(s) (Ref. L1) 0° L1 (45° steps) e ceases,	Test (rtment: pany: conditions: Disturbane Voltage di results: lormal perfor	EM V-Labor SGS EN 61000-4-11 vota Votage / frequency: Test phase: Decude test: Test description Distances per ste Description Distances per ste Description Distances per ste Distances per ste	acified by mar ation of perfo	Serial no: Operating modes: Comment1: Comment2: Date of test tinter ruptions and variations f 00.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_0/6-20per (per phase angle) / 10.5 sec Duration 300 periods utacturer, requestor or purch mance which cesses after th	AC 100V 6 15.05.2019 est delaybetweer	00Hz Phase angle(s) (Ref. L1) 0° L1 (45° steps) 2 ceases,
Department: Company: Test conditions: Step Disturbat 1 Voltage c Test results: Normal perfo , TemporaryIo and from whi	EM 4-Labor SGS EN 61000-4-11 voltag Voltage / frequency: Test phase: Executed test: Test description Distur bances per ster noe lip / short interruption	10 Si 	Serial no: Operating modes: Comment1: Comment2: Date of test: Linter ruptions and variations to 0.0 V / 60.0 Hz 0.0 V / 60.0 Hz ngle phase / L1-N 1000-4-11_70%-25per [per phase angle] / 10.5 sec of Duration 30 periods ufacturer, requestor or purch monce which ceases after th soromd performance, with	AC 100V 15.05201 test delay betwee e distur banco sut oper ator i	60Hz 9 Phase angle(s) (Ref. L1) 0° L1 (45° steps) e ceases,	Test (Test (Test) Test (N Test)	rtment: pany: conditions: Voltage di results: lormal perfor 'emporarylos nd from Wilc	EMV-Labor SGS EN 61000-4-11 volta Voltage / freq.vency. Test phase: Executed test: Test description: Distur bances per ste 29 p / short interruption mance within limits spe sof functionor degrad the equipment under	acified by mar ation of perfor	Serial no: Operating modes: Comment1: Comment2: Date of test: Linter ruptions and variations 1 0.0 V / 60.0 Hz ngle phase / L1-N 31000-4-11_0%-250per (per phase angle) / 10.5 sec of Duration 300 periods utfacturer, requestor or purch rmonce which ceases after this normal per formance, with	AC 100V 6 15.052019 est delaybetween eser es distur bance ut operator in	00Hz Phase angle(s) (Ref. L1) 0° L1 (45° steps) 2 ceases,
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TRF No. IEC60601_1_2E_EMC

	Tabulated Results f	or Voltage Dips and I	nterruptions
	240		
	50		
Point of application	Voltage reduction	Period (Cycles)	Results
Mains	0	0.5	1
Mains	0	1	1
Mains	70	25/30 (50/60 Hz)	1
Point of application	Voltage Interruptions	Period (Cycles)	Results
Mains	0	250/300 (50/60 Hz)	1

Supplementary information:

Results Descriptions:

X – Not performed nor required.

1 – Compliant – No observed response from EUT.

Name: Departme Company:			Serial no:	K MLC8-23 EUT 3 IV 50Hz 1019	Name Depa Comp	rtment:	Ratkovic EMV-Labor SGS		Manufacturer: Serial no: Operating modes: Comment1: Comment2: Date of test:	ADLINK M AC 240V	
Test cond	itions: EN 61000-4-11 volta; Voltage / frequency: Test phase: Executed test: Test description Disturbances per ste	2 S	t interruptions and variations test 40.0 V / 50.0 Hz Ingle phase / L1-N 61000-4-11_0% 0.5per (per phase angle) / 10.5 sec delaybet	ieen	Test	conditions:	EN 61000-4-11 voltag Voltage / freq uency: Test phase: Executed test: Test description: Disturbances per ste	24 S	t interruptions and variations te 40.0 V / 50.0 Hz ingle phase / L1-N 61000-4-11_0% 1per (per phase angle) / 10.5 sec di		n
Step D	istur bance	Test level	Duration	Phase angle(s) (Ref. L1)	Step	Disturban	æ	Test level	Duration		Phase angle(s) (Ref. L1)
1 V	oltage dip / short interruption	0 %	0.5 periods	0° L1 (45° steps)	1	Voltage di	p / short interruption	0 %	1 period		0° L1 (45° steps)
 Temp and fr Temp requit Loss of owing Comment 	Installable ELC 413/M 520201y Speelwoop & S							Intervention Intervention Intervention ILC8-23 EUT 3			
Test conditions: EN 61000-4-11 voltage dips, short interruptions and variations test. Voltage / frequency: 240.0V / 500 Hz Test phase: Single phase / L1-N Executed test: 61000-4-11_70%-25per Test description: Disturbances per step: 3 (per phase angle) / 10.5 sec delaybetween						Disturbane	Voltage / freq uency: Test phase: Executed test: Test description: Disturbances per ste	24 S	t interruptions and variations te 40.0 V / 50.0 Hz Ingle phase / L1-N 61000-4-11_0%-250per (per phase angle) / 10.5 sec do		n Phase angle(s) (Ref. L1)
· ·	isturbance bltage dip / short interruption	Test level 70 %	Duration 25 periods	Phase angle(s) (Ref. L1) 0° L1 (45° steps)	Step 1	-	p/shortinterruption	0 %	250 periods		0° L1 (45° steps)
Test results:							s of function or degrada the equipment under the s of function or degrada ator intervention nor degradation of peri- ge to hardware or softw	ation of perfo est recovers ation of perfo formance wh vare, or loss	of data	disturbano ut operator i h	ntervention
	Tested with SPS EMC 4.1	3/PA S20000 by Spite	nbeger & Spiles GmbH & Co. K.G. Schmidat. 3234, 94294 Viechtsch, Gen	ny, 15.052019			Tested with SPS ENC 41.	3/ PA S20000 by Spitze	nbeger & Spies GntbH & Co. K G, Schmidat: 3234, 94294V	riechtach, Gemeny, 15	5.052079

IEC	60601-1-2	

1.21 Test Conditions and Results – Electrical transient conduction along supply lines

ISO 7637-2: 2011	TEST: Electrical transient conduction along supply lines	Verdict
		N/A
cars and light commercia	ion: For ME EQUIPMENT and ME SYSTEMS intended to be installed in p al vehicles including ambulances fitted with 12 V electrical systems or com ances fitted with 24 V electrical systems.	

2.0 Disclaimer

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End of the Report